

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## DECLARATION OF COMPLIANCE SAR RF EXPOSURE EVALUATION

<p><b><u>Test Lab</u></b></p> <p><b>CELLTECH LABS INC.</b> Testing and Engineering Services 1955 Moss Court Kelowna, B.C. Canada V1Y 9L3 Phone: 250-448-7047 Fax: 250-448-7046 e-mail: info@celltechlabs.com web site: www.celltechlabs.com</p>	<p><b><u>Applicant Information</u></b></p> <p><b>PLANTRONICS INC.</b> 345 Encinal Street Santa Cruz, CA 95060 United States</p>
<p><b>Model(s) Tested:</b> CS55 Headset (Long Boom) CS55 Micro Headset (Short Boom)</p> <p><b>Serial No.(s) Tested:</b> R790922876 (CS55 Headset) R790058767 (CS55 Micro Headset)</p>	
<p><b>Rule Part(s):</b> FCC 47 CFR §2.1093; IC RSS-102 Issue 1 (Provisional)</p> <p><b>Test Procedure(s):</b> FCC OET Bulletin 65, Supplement C (01-01)</p> <p><b>Device Classification:</b> Part 15 Unlicensed PCS portable Tx held to ear (PUE)</p> <p><b>Device Description:</b> Wireless Office Headset System (Headset Unit)</p> <p><b>Mode of Operation:</b> TDMA (Time Division Multiple Access)</p>	
<p><b>Tx Frequency Range(s):</b> 1921.536 - 1928.448 MHz</p> <p><b>RF Output Power Tested:</b> 8.82 dBm (7.62 mW) Peak Conducted (CS55 Headset) 8.68 dBm (7.38 mW) Peak Conducted (CS55 Micro Headset)</p> <p><b>Max. Duty Cycle Tested:</b> 8.3% Source-Based Time-Averaged (Crest Factor: 1:12.05)</p> <p><b>Antenna Type(s) Tested:</b> Internal Bifurcated F over ground plane</p> <p><b>Battery Type(s) Tested:</b> Lithium-ion Polymer 3.75 V, 190 mAh (P/N: 65358-01)</p>	
<p><b>Max. SAR Level(s) Evaluated:</b> Head: 0.001495 W/kg (Maximum SAR from Area Scan)</p>	

Celltech Labs Inc. declares under its sole responsibility that this wireless device is compliant with the Specific Absorption Rate (SAR) RF exposure requirements specified in FCC 47 CFR §2.1093 and Health Canada's Safety Code 6. The device was tested in accordance with the measurement standards and procedures specified in FCC OET Bulletin 65, Supplement C (Edition 01-01), Industry Canada RSS-102 Issue 1 (Provisional) and IEEE Standard 1528-2003 for the General Population / Uncontrolled Exposure environment. All measurements were performed in accordance with the SAR system manufacturer recommendations.

I attest to the accuracy of data. All measurements were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

This test report shall not be reproduced partially, or in full, without the prior written approval of Celltech Labs Inc. The results and statements contained in this report pertain only to the device(s) evaluated.

**Tested By:**




**Sean Johnston**  
Compliance Technologist  
Celltech Labs Inc.

**Reviewed By:**



**Spencer Watson**  
Senior Compliance Technologist  
Celltech Labs Inc.



<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 1 of 49				

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## TABLE OF CONTENTS

<b>1.0 INTRODUCTION</b>	<b>3</b>
<b>2.0 DESCRIPTION of Device Under Test (DUT)</b>	<b>3</b>
<b>3.0 SAR MEASUREMENT SYSTEM</b>	<b>4</b>
<b>4.0 MEASUREMENT SUMMARY</b>	<b>5</b>
<b>5.0 DETAILS OF SAR EVALUATION</b>	<b>6</b>
<b>DETAILS OF SAR EVALUATION (Cont.)</b>	<b>7</b>
<b>6.0 EVALUATION PROCEDURES</b>	<b>7</b>
<b>EVALUATION Procedures (Cont.)</b>	<b>8</b>
<b>7.0 SYSTEM PERFORMANCE CHECK</b>	<b>9</b>
<b>8.0 SIMULATED EQUIVALENT TISSUES</b>	<b>10</b>
<b>9.0 SAR SAFETY LIMITS</b>	<b>10</b>
<b>10.0 ROBOT SYSTEM SPECIFICATIONS</b>	<b>11</b>
<b>11.0 Probe Specification (ET3DV6)</b>	<b>12</b>
<b>12.0 SAM PHANTOM V4.0C</b>	<b>12</b>
<b>13.0 DEVICE HOLDER</b>	<b>12</b>
<b>14.0 TEST EQUIPMENT LIST</b>	<b>13</b>
<b>15.0 MEASUREMENT UNCERTAINTIES</b>	<b>14</b>
<b>MEASUREMENT UNCERTAINTIES (Cont.)</b>	<b>15</b>
<b>16.0 REFERENCES</b>	<b>16</b>
<b>APPENDIX A - SAR MEASUREMENT DATA</b>	<b>17</b>
<b>APPENDIX B - SYSTEM PERFORMANCE CHECK DATA</b>	<b>27</b>
<b>APPENDIX C - MEASURED FLUID DIELECTRIC PARAMETERS</b>	<b>30</b>
<b>APPENDIX D - SAR TEST SETUP &amp; DUT PHOTOGRAPHS</b>	<b>33</b>
<b>APPENDIX E - SYSTEM VALIDATION</b>	<b>47</b>
<b>APPENDIX F - PROBE CALIBRATION</b>	<b>48</b>
<b>APPENDIX G - SAM PHANTOM CERTIFICATE OF CONFORMITY</b>	<b>49</b>

## 1.0 INTRODUCTION

This measurement report demonstrates that the PLANTRONICS Models: CS55 Headset / CS55 Micro Headset Wireless Office Headset System complies with the SAR (Specific Absorption Rate) RF exposure requirements specified in FCC 47 CFR §2.1093 (see reference [1]) and Health Canada's Safety Code 6 (see reference [2]) for the General Population / Uncontrolled Exposure environment. The test procedures described in FCC OET Bulletin 65, Supplement C, Edition 01-01 (see reference [3]), IC RSS-102 Issue 1 (Provisional) (see reference [4]), and IEEE Standard 1528-2003 (see reference [5]) were employed. A description of the product, operating configuration, detailed summary of the test results, methodology and procedures used in the evaluation, equipment used, and the various provisions of the rules are included within this test report.

## 2.0 DESCRIPTION OF DEVICE UNDER TEST (DUT)

<b>FCC Rule Part(s)</b>	47 CFR §2.1093		
<b>IC Rule Part(s)</b>	RSS-102 Issue 1 (Provisional)		
<b>FCC Device Classification</b>	Part 15 Unlicensed PCS portable Tx held to ear (PUE)	15(D)	
<b>Test Procedure(s)</b>	FCC OET Bulletin 65, Supplement C (01-01)		
	IEEE Standard 1528-2003		
<b>Device Description</b>	Wireless Office Headset System		
<b>Model(s) Tested</b>	CS55 Headset	Long Boom	
	CS55 Micro Headset	Short Boom	
<b>Serial No.(s) Tested</b>	R79O922876	CS55 Headset	Identical Prototype
	R79O058767	CS55 Micro Headset	Identical Prototype
<b>Tx Frequency Range(s)</b>	1921.536 - 1928.448 MHz	UPCS Band	
<b>Mode(s) of Operation</b>	TDMA (Time Division Multiple Access)		
<b>Maximum Duty Cycle Tested</b>	8.3%	Source-Based Time-Averaged	Crest Factor: 1:12.05
<b>Max. RF Output Power Tested</b>	8.82 dBm	7.62 mW	Peak Conducted CS55 Headset
	8.68 dBm	7.38 mW	Peak Conducted CS55 Micro Headset
<b>Battery Type(s) Tested</b>	Lithium-ion Polymer	3.75 V, 190 mAh	P/N: 65358-01
<b>Antenna Type(s) Tested</b>	Internal	Bifurcated F over ground plane	

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

### 3.0 SAR MEASUREMENT SYSTEM


Celltech Labs Inc. SAR measurement facility utilizes the Dosimetric Assessment System (DASY™) manufactured by Schmid & Partner Engineering AG (SPEAG™) of Zurich, Switzerland. The DASY4 measurement system is comprised of the measurement server, robot controller, computer, near-field probe, probe alignment sensor, specific anthropomorphic mannequin (SAM) phantom, and various planar phantoms for brain and/or body SAR evaluations. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF). A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The Staubli robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the DASY4 measurement server. The DAE4 utilizes a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16-bit AD-converter and a command decoder and control logic unit. Transmission to the DASY4 measurement server is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe-mounting device includes two different sensor systems for frontal and sidewise probe contacts. The sensor systems are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



DASY4 Measurement System with SAM Phantom



DASY4 Measurement System with SAM Phantom

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Headset		
Model(s):	CS55 Headset, CS55 Micro Headset	Tx Frequency Range:	1921.536 - 1928.448 MHz		
2005 Celltech Labs Inc.		This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.			4 of 49

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102


## 4.0 MEASUREMENT SUMMARY

### HEAD SAR EVALUATION RESULTS

Freq. (MHz)	Chan.	Test Mode	DUT Model No.	DUT Model Type	Battery Type	Antenna Type	Phantom Section	Test Position	Max. Cond. Power (dBm)	Maximum SAR from Area Scan (W/kg)
1924.992	3	TDMA	CS55	Long Boom	Li-ion Polymer	Internal	Right Ear	Cheek/Touch	8.82	0.001495
1924.992	3	TDMA	CS55 Micro	Short Boom	Li-ion Polymer	Internal	Right Ear	Cheek/Touch	8.68	0.000873
1924.992	3	TDMA	CS55	Long Boom	Li-ion Polymer	Internal	Right Ear	Ear/Tilt (15°)	8.82	0.001089
1924.992	3	TDMA	CS55 Micro	Short Boom	Li-ion Polymer	Internal	Right Ear	Ear/Tilt (15°)	8.68	0.000982
1924.992	3	TDMA	CS55	Long Boom	Li-ion Polymer	Internal	Left Ear	Cheek/Touch	8.82	0.000879
1924.992	3	TDMA	CS55 Micro	Short Boom	Li-ion Polymer	Internal	Left Ear	Cheek/Touch	8.68	0.001125
1924.992	3	TDMA	CS55	Long Boom	Li-ion Polymer	Internal	Left Ear	Ear/Tilt (15°)	8.82	0.001098
1924.992	3	TDMA	CS55 Micro	Short Boom	Li-ion Polymer	Internal	Left Ear	Ear/Tilt (15°)	8.68	0.001338
<b>ANSI / IEEE C95.1 1999 - SAFETY LIMIT</b>										
<b>BRAIN: 1.6 W/kg (averaged over 1 gram)</b>										
<b>Spatial Peak - Uncontrolled Exposure / General Population</b>										
<b>Test Date(s)</b>	August 2, 2005				<b>Relative Humidity</b>			31	%	
<b>Measured Fluid Type</b>	1925 MHz Brain				<b>Atmospheric Pressure</b>			102.1	kPa	
<b>Dielectric Constant</b> $\epsilon_r$	<b>IEEE Target</b>		<b>Measured</b>	<b>Deviation</b>	<b>Ambient Temperature</b>			24.5	°C	
	40.0	± 5%	38.2	-4.5%	<b>Fluid Temperature</b>			22.4	°C	
<b>Conductivity</b> $\sigma$ (mho/m)	<b>IEEE Target</b>		<b>Measured</b>	<b>Deviation</b>	<b>Fluid Depth</b>			≥ 15	cm	
	1.40	± 5%	1.42	+1.4%	<b><math>\rho</math> (Kg/m<sup>3</sup>)</b>			1000		

Note(s):

- The measurement results were obtained with the DUT tested in the conditions described in this report. Detailed measurement data and plots showing the maximum SAR location of the DUT are reported in Appendix A.
- The 1g averaged SAR was not measured because the peak SAR value from the area scan evaluations for each test configuration was less than 1% of 1.6 mW/g (1g average limit). The peak SAR values measured during the area scan evaluations for each test configuration are reported.
- The transmission band of the DUT is less than 10 MHz; therefore mid channel data only is reported (per FCC OET Bulletin 65, Supplement C, Edition 01-01 - see reference [3]).
- The ambient and fluid temperatures were measured prior to, and during, the fluid dielectric parameter check and the SAR evaluations. The temperatures reported were consistent for all measurement periods.
- The dielectric parameters of the simulated tissue mixture were measured prior to the SAR evaluations using an ALS-PR-DIEL Dielectric Probe Kit and an HP 8753ET Network Analyzer (see Appendix E for measured fluid dielectric parameters).
- The SAR measurements were performed within 24 hours of the system performance check.

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 5 of 49				

## 5.0 DETAILS OF SAR EVALUATION

The PLANTRONICS Models: *CS55 Headset / CS55 Micro Headset* Wireless Office Headset System was compliant for localized Specific Absorption Rate (SAR) based on the test provisions and conditions described below. The detailed test setup photographs are shown in Appendix D.

### Ear-held Configuration

- 1) The DUT was tested in an ear-held configuration on both the left and right sections of the SAM phantom at the mid channel of the operating band. The transmission band of the DUT is less than 10 MHz; therefore mid channel data only is reported (per FCC OET Bulletin 65, Supplement C, Edition 01-01 - see reference [3]).
  - a) The headset unit was placed in the device holder in a normal operating position with the test device reference point located along the vertical centerline on the front of the device aligned to the ear reference point, with the center of the earpiece touching the center of the ear spacer of the SAM phantom.
  - b) With the headset unit positioned parallel to the cheek, the test device reference point was aligned to the ear reference point on the head phantom, and the vertical centerline was aligned to the phantom reference plane (initial ear position).
  - c) While maintaining the three alignments, the body of the headset was gradually adjusted to each of the following test positions:
    - Cheek/Touch Position: the headset was brought toward the mouth of the head phantom by pivoting against the ear reference point until any point of the mouthpiece or keypad touched the phantom.

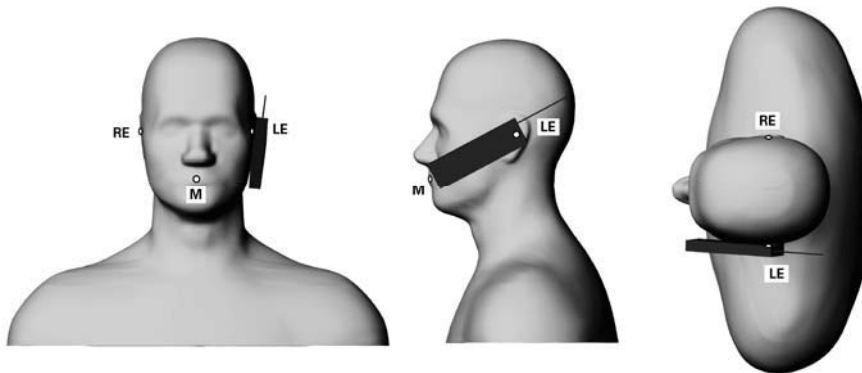


Figure 1. Position 1, “cheek” or “touch” position. The reference points for the right ear (RE), left ear (LE) and mouth (M), which define the reference plane for device positioning, are indicated (Shoulders are shown for illustration only).

- Ear/Tilt Position: With the device aligned in the Cheek/Touch position, the headset was tilted away from the mouth with respect to the test device reference point by 15 degrees.

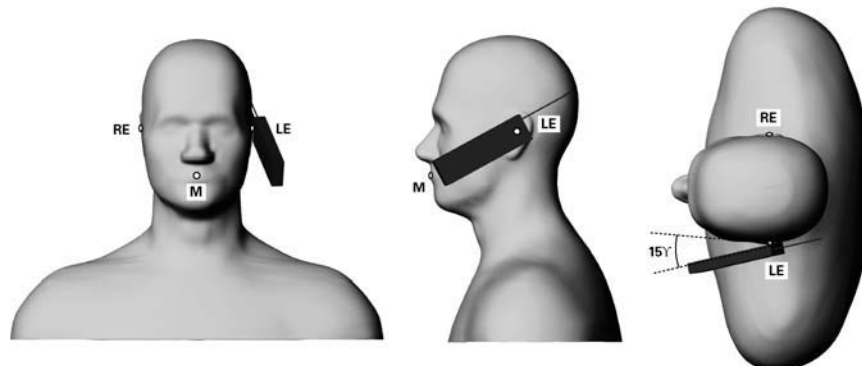


Figure 2. Position 2, “tilted position.” The reference points for the right ear (RE), left ear (LE) and mouth (M), which define the reference plane for device positioning, are indicated (Shoulders are shown for illustration only).

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## DETAILS OF SAR EVALUATION (Cont.)

### DUT Test Modes & Power Settings

- 2) The base unit was placed 1-meter away from the headset unit. After a 10 second period the link contact switch on the headset unit was depressed. The green LED on the front face of the base unit is illuminated and the base unit clicks as the relays close. The green LED on the headset unit then begins to flash to indicate the device is now in test mode.
- 3) The DUT was tested at the max. power setting in TDMA mode with a duty cycle of 8.3% (crest factor = 1:12.05).
- 4) The conducted power levels(s) of the DUT were measured prior to the SAR evaluations using a Rohde & Schwarz CMD60 digital radiocommunication tester according to the measurement procedures described in FCC 47 CFR §2.1046.
- 5) The DUT was tested with a fully charged battery for each test.
- 6) The ambient and fluid temperatures were measured prior to, and during, the fluid dielectric parameter check and the SAR evaluations. The temperatures reported were consistent for all measurement periods.
- 7) The dielectric parameters of the simulated tissue mixture were measured prior to the SAR evaluations using an ALS-PR-DIEL Dielectric Probe Kit and an HP 8753ET Network Analyzer (see Appendix E for measured fluid dielectric parameters).
- 8) The SAR measurements were performed within 24 hours of the system performance check.
- 9) The 1g averaged SAR was not measured because the peak SAR value from the area scan evaluations for each test configuration was less than 1% of 1.6 mW/g (1g average limit). The peak SAR values measured during the area scan evaluations for each test configuration are reported.

## 6.0 EVALUATION PROCEDURES


- a. (i) The evaluation was performed in the applicable area of the phantom depending on the type of device being tested. For devices held to the ear during normal operation, both the left and right ear positions were evaluated using the SAM phantom.  
(ii) For body-worn and face-held devices a planar phantom was used.
- b. The SAR was determined by a pre-defined procedure within the DASY4 software. Upon completion of a reference and optical surface check, the exposed region of the phantom was scanned near the inner surface with a grid spacing of 15mm x 15mm.

An area scan was determined as follows:

- c. Based on the defined area scan grid, a more detailed grid is created to increase the points by a factor of 10. The interpolation function then evaluates all field values between corresponding measurement points.
- d. A linear search is applied to find all the candidate maxima. Subsequently, all maxima are removed that are >2 dB from the global maximum. The remaining maxima are then used to position the cube scans.

A 1g and 10g spatial peak SAR was determined as follows:

- e. Extrapolation is used to find the points between the dipole center of the probe and the surface of the phantom. This data cannot be measured, since the center of the dipoles is 2.7 mm away from the tip of the probe and the distance between the surface and the lowest measuring point is 1.4 mm (see probe calibration document in Appendix F). The extrapolation was based on trivariate quadratics computed from the previously calculated 3D interpolated points nearest the phantom surface.
- f. Interpolated data is used to calculate the average SAR over 1g and 10g cubes by spatially discretizing the entire measured cube. The volume used to determine the averaged SAR is a 1mm grid (42875 interpolated points).
- g. A zoom scan volume of 32 mm x 32 mm x 30 mm (5x5x7 points) centered at the peak SAR location determined from the area scan is used for all zoom scans for devices with a transmit frequency < 800 MHz. Zoom scans for frequencies ≥ 800 MHz are determined with a scan volume of 30 mm x 30 mm x 30 mm (7x7x7 points) to ensure complete capture of the peak spatial-average SAR.

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Headset	
Model(s):	CS55 Headset, CS55 Micro Headset	Tx Frequency Range:	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 7 of 49				

## EVALUATION PROCEDURES (Cont.)

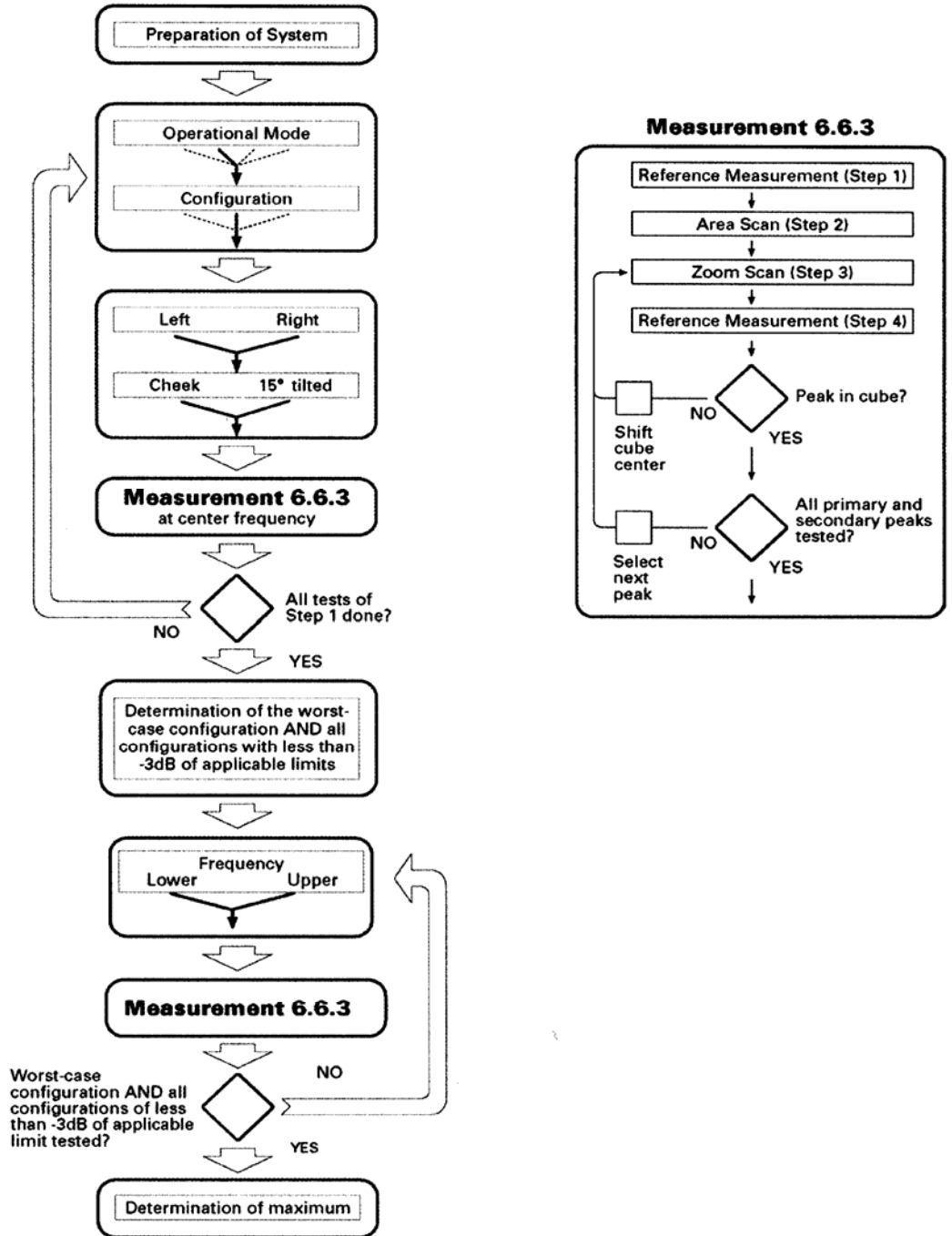


Figure 3. Flow Chart for determining the largest peak spatial-average SAR from all device configurations per IEEE Standard 1528-2003 (see reference [5]).



## 7.0 SYSTEM PERFORMANCE CHECK

Prior to the SAR evaluations a system check was performed at the planar section of the SAM phantom with a 1900MHz dipole (see Appendix E for system validation procedures). The dielectric parameters of the simulated tissue mixture were measured prior to the system performance check using an ALS-PR-DIEL Dielectric Probe Kit and an HP 8753ET Network Analyzer (see Appendix C for measured fluid dielectric parameters). A forward power of 250 mW was applied to the dipole and the system was verified to a tolerance of  $\pm 10\%$  (see Appendix B for system performance check test plot).

### SYSTEM PERFORMANCE CHECK EVALUATION

Test Date	1900MHz Equiv. Tissue	SAR 1g (W/kg)			Dielectric Constant $\epsilon_r$			Conductivity $\sigma$ (mho/m)			$\rho$ (Kg/m <sup>3</sup> )	Amb. Temp. (°C)	Fluid Temp. (°C)	Fluid Depth (cm)	Humid. (%)	Barom. Press. (kPa)
		IEEE Target	Meas.	Dev.	IEEE Target	Meas.	Dev.	IEEE Target	Meas.	Dev.						
8/2/05	Brain	9.93 $\pm 10\%$	10.9	+9.8%	40.0 $\pm 5\%$	38.2	-4.5%	1.40 $\pm 5\%$	1.43	+2.1%	1000	24.6	23.3	$\geq 15$	30	102.2

Note(s):

1. The ambient and fluid temperatures were measured prior to, and during, the fluid dielectric parameter check and the system performance check. The temperatures listed in the table above were consistent for all measurement periods.

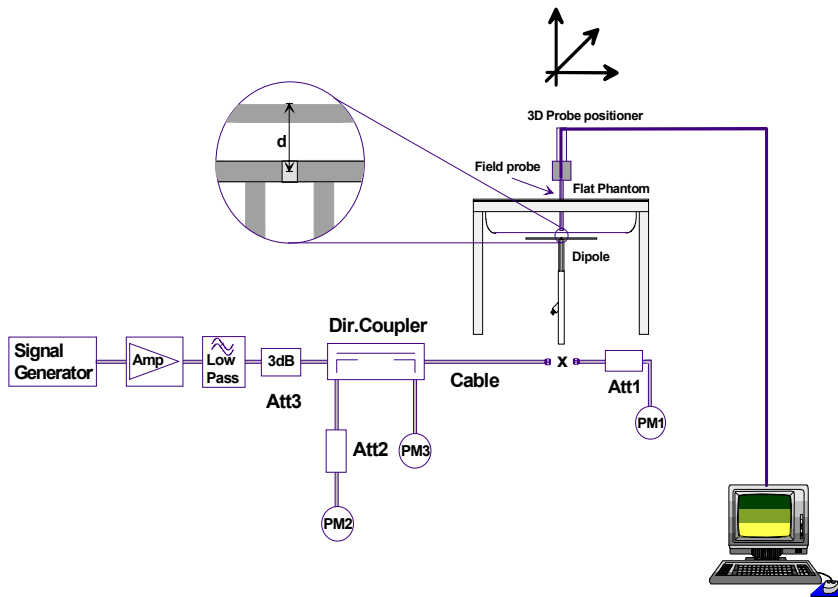


Figure 1. System Performance Check Setup



1900MHz Dipole Setup

## 8.0 SIMULATED EQUIVALENT TISSUES

The 1900/1925MHz simulated equivalent tissue mixture consists of Glycol-monobutyl, water, and salt. The fluids were prepared according to standardized procedures and measured for dielectric parameters (permittivity and conductivity).

1900/1925 MHz SIMULATED TISSUE MIXTURE		
INGREDIENT	1900 MHz Brain	1925 MHz Brain
	System Performance Check	DUT Evaluation
Water	55.85 %	55.85 %
Glycol Monobutyl	44.00 %	44.00 %
Salt	0.15 %	0.15 %

## 9.0 SAR SAFETY LIMITS

EXPOSURE LIMITS	SAR (W/kg)	
	(General Population / Uncontrolled Exposure Environment)	(Occupational / Controlled Exposure Environment)
Spatial Average (averaged over the whole body)	0.08	0.4
Spatial Peak (averaged over any 1 g of tissue)	1.60	8.0
Spatial Peak (hands/wrists/feet/ankles averaged over 10 g)	4.0	20.0

Notes:

1. Uncontrolled environments are defined as locations where there is potential exposure of individuals who have no knowledge or control of their potential exposure.
2. Controlled environments are defined as locations where there is potential exposure of individuals who have knowledge of their potential exposure and can exercise control over their exposure.

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## 10.0 ROBOT SYSTEM SPECIFICATIONS

### Specifications

**POSITIONER:** Stäubli Unimation Corp. Robot Model: RX60L  
**Repeatability:** 0.02 mm  
**No. of axis:** 6

### Data Acquisition Electronic (DAE) System

#### Cell Controller

**Processor:** AMD Athlon XP 2400+  
**Clock Speed:** 2.0 GHz  
**Operating System:** Windows XP Professional

#### Data Converter

**Features:** Signal Amplifier, multiplexer, A/D converter, and control logic  
**Software:** DASY4 software  
**Connecting Lines:** Optical downlink for data and status info.  
 Optical uplink for commands and clock

### DASY4 Measurement Server

**Function:** Real-time data evaluation for field measurements and surface detection  
**Hardware:** PC/104 166MHz Pentium CPU; 32 MB chipdisk; 64 MB RAM  
**Connections:** COM1, COM2, DAE, Robot, Ethernet, Service Interface

### E-Field Probe

**Model:** ET3DV6  
**Serial No.:** 1387  
**Construction:** Triangular core fiber optic detection system  
**Frequency:** 10 MHz to 6 GHz  
**Linearity:**  $\pm 0.2$  dB (30 MHz to 3 GHz)

### Phantom(s)

**Type:** SAM V4.0C  
**Shell Material:** Fiberglass  
**Thickness:** 2.0  $\pm$  0.1 mm  
**Volume:** Approx. 25 liters

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## 11.0 PROBE SPECIFICATION (ET3DV6)

Construction:	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g. glycol)
Calibration:	In air from 10 MHz to 2.5 GHz In brain simulating tissue at frequencies of 900 MHz and 1.8 GHz (accuracy $\pm 8\%$ )
Frequency:	10 MHz to >6 GHz; Linearity: $\pm 0.2$ dB (30 MHz to 3 GHz)
Directivity:	$\pm 0.2$ dB in brain tissue (rotation around probe axis) $\pm 0.4$ dB in brain tissue (rotation normal to probe axis)
Dynamic Range:	5 $\mu$ W/g to >100 mW/g; Linearity: $\pm 0.2$ dB
Surface Detection:	$\pm 0.2$ mm repeatability in air and clear liquids over diffuse reflecting surfaces
Dimensions:	Overall length: 330 mm Tip length: 16 mm Body diameter: 12 mm Tip diameter: 6.8 mm Distance from probe tip to dipole centers: 2.7 mm
Application:	General dosimetry up to 3 GHz Compliance tests of mobile phone



ET3DV6 E-Field Probe

## 12.0 SAM PHANTOM V4.0C

The SAM phantom V4.0C is a fiberglass shell phantom with a 2.0 mm (+/-0.2 mm) shell thickness for left and right head and flat planar area integrated in a wooden table. The shape of the fiberglass shell corresponds to the phantom defined by SCC34-SC2. The device holder positions are adjusted to the standard measurement positions in the three sections (see Appendix G for specifications of the SAM phantom V4.0C).




SAM Phantom V4.0C

## 13.0 DEVICE HOLDER

The DASY4 device holder has two scales for device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear openings). The plane between the ear openings and the mouth tip has a rotation angle of 65°. The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections.




Device Holder

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Headset		
Model(s):	CS55 Headset, CS55 Micro Headset	Tx Frequency Range:	1921.536 - 1928.448 MHz		
2005 Celltech Labs Inc.		This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.			12 of 49

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## 14.0 TEST EQUIPMENT LIST

USED	TEST EQUIPMENT DESCRIPTION	ASSET NO.	SERIAL NO.	DATE CALIBRATED	CALIBRATION DUE DATE	
x	Schmid & Partner DASY4 System	-	-	-	-	
x	-DASY4 Measurement Server	00158	1078	N/A	N/A	
x	-Robot	00046	599396-01	N/A	N/A	
	-DAE4	00019	353	15Jun05	15Jun06	
x	-DAE3	00018	370	25Jan05	25Jan06	
x	-ET3DV6 E-Field Probe	00016	1387	18Mar05	18Mar06	
	-ET3DV6 E-Field Probe	00017	1590	20May05	20May06	
	-EX3DV4 E-Field Probe	00125	3547	21Jan05	21Jan06	
	-300MHz Validation Dipole	00023	135	26Oct04	26Oct05	
	-450MHz Validation Dipole	00024	136	04Nov04	04Nov05	
	-835MHz Validation Dipole	00022	411	Brain	30Mar05	30Mar06
				Body	12Apr05	12Apr06
	-900MHz Validation Dipole	00020	054	Brain	10Jun05	10Jun06
				Body	10Jun05	10Jun06
	-1800MHz Validation Dipole	00021	247	Brain	14Jun05	14Jun06
				Body	14Jun05	14Jun06
x	-1900MHz Validation Dipole	00032	151	Brain	17Jun05	17Jun06
				Body	22Apr05	22Apr06
	-2450MHz Validation Dipole	00025	150	Brain	30Sep04	30Sep05
				Body	22Apr05	22Apr06
	-5000MHz Validation Dipole	00126	1031	Brain	11Jan05	11Jan06
				Body	11Jan05	11Jan06
x	-SAM Phantom V4.0C	00154	1033	N/A	N/A	
	-Barski Planar Phantom	00155	03-01	N/A	N/A	
	-Plexiglas Planar Phantom	00156	161	N/A	N/A	
	-Validation Planar Phantom	00157	137	N/A	N/A	
	HP 85070C Dielectric Probe Kit	00033	N/A	N/A	N/A	
x	ALS-PR-DIEL Dielectric Probe Kit	00160	260-00953	N/A	N/A	
x	Gigatronics 8652A Power Meter	00110	1835801	16Apr05	16Apr06	
	Gigatronics 8652A Power Meter	00008	1835267	29Apr05	29Apr06	
	Gigatronics 8652A Power Meter	00007	1835272	18Oct04	18Oct05	
x	Gigatronics 80701A Power Sensor	00011	1833542	08Oct04	08Oct05	
x	Gigatronics 80701A Power Sensor	00109	1834366	16Apr05	16Apr06	
x	HP 8753ET Network Analyzer	00134	US39170292	04May05	04May06	
x	HP 8648D Signal Generator	00005	3847A00611	29Apr05	29Apr06	
x	Rohde & Schwarz CMD60 Test Set	na	844365/013	11Nov04	11Nov05	
x	Rohde & Schwarz CMD60 Test Set	na	830008/003	01Jun05	31May06	
x	Amplifier Research 5S1G4 Power Amplifier	00106	26235	N/A	N/A	

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Headset	
Model(s):	CS55 Headset, CS55 Micro Headset	Tx Frequency Range:	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 13 of 49				

## 15.0 MEASUREMENT UNCERTAINTIES

UNCERTAINTY BUDGET FOR DEVICE EVALUATION						
Error Description	Uncertainty Value $\pm\%$	Probability Distribution	Divisor	$c_i$ 1g	Uncertainty Value $\pm\%$ (1g)	$V_i$ or $V_{eff}$
<b>Measurement System</b>						
Probe calibration	5.5	Normal	1	1	5.5	$\infty$
Axial isotropy of the probe	4.7	Rectangular	1.732050808	0.7	1.9	$\infty$
Spherical isotropy of the probe	9.6	Rectangular	1.732050808	0.7	3.9	$\infty$
Spatial resolution	0	Rectangular	1.732050808	1	0.0	$\infty$
Boundary effects	1	Rectangular	1.732050808	1	0.6	$\infty$
Probe linearity	4.7	Rectangular	1.732050808	1	2.7	$\infty$
Detection limit	1	Rectangular	1.732050808	1	0.6	$\infty$
Readout electronics	0.3	Normal	1	1	0.3	$\infty$
Response time	0.8	Rectangular	1.732050808	1	0.5	$\infty$
Integration time	2.6	Rectangular	1.732050808	1	1.5	$\infty$
RF ambient conditions	3	Rectangular	1.732050808	1	1.7	$\infty$
Mech. constraints of robot	0.4	Rectangular	1.732050808	1	0.2	$\infty$
Probe positioning	2.9	Rectangular	1.732050808	1	1.7	$\infty$
Extrapolation & integration	1	Rectangular	1.732050808	1	0.6	$\infty$
<b>Test Sample Related</b>						
Device positioning	2.9	Normal	1	1	2.9	12
Device holder uncertainty	3.6	Normal	1	1	3.6	8
Power drift	5	Rectangular	1.732050808	1	2.9	$\infty$
<b>Phantom and Setup</b>						
Phantom uncertainty	4	Rectangular	1.732050808	1	2.3	$\infty$
Liquid conductivity (target)	5	Rectangular	1.732050808	0.64	1.8	$\infty$
Liquid conductivity (measured)	2.5	Normal	1	0.64	1.6	$\infty$
Liquid permittivity (target)	5	Rectangular	1.732050808	0.6	1.7	$\infty$
Liquid permittivity (measured)	2.5	Normal	1	0.6	1.5	$\infty$
<b>Combined Standard Uncertainty</b>					<b>10.58</b>	
<b>Expanded Uncertainty (k=2)</b>					<b>21.16</b>	

Measurement Uncertainty Table in accordance with IEEE Standard 1528-2003 (see reference [5])

## MEASUREMENT UNCERTAINTIES (CONT.)

UNCERTAINTY BUDGET FOR SYSTEM VALIDATION						
Error Description	Uncertainty Value ±%	Probability Distribution	Divisor	ci 1g	Uncertainty Value ±% (1g)	V <sub>i</sub> or V <sub>eff</sub>
<b>Measurement System</b>						
Probe calibration	5.5	Normal	1	1	5.5	∞
Axial isotropy of the probe	4.7	Rectangular	1.732050808	1	2.7	∞
Spherical isotropy of the probe	0	Rectangular	1.732050808	1	0.0	∞
Spatial resolution	0	Rectangular	1.732050808	1	0.0	∞
Boundary effects	1	Rectangular	1.732050808	1	0.6	∞
Probe linearity	4.7	Rectangular	1.732050808	1	2.7	∞
Detection limit	1	Rectangular	1.732050808	1	0.6	∞
Readout electronics	0.3	Normal	1	1	0.3	∞
Response time	0	Rectangular	1.732050808	1	0.0	∞
Integration time	0	Rectangular	1.732050808	1	0.0	∞
RF ambient conditions	3	Rectangular	1.732050808	1	1.7	∞
Mech. constraints of robot	0.4	Rectangular	1.732050808	1	0.2	∞
Probe positioning	2.9	Rectangular	1.732050808	1	1.7	∞
Extrapolation & integration	1	Rectangular	1.732050808	1	0.6	∞
<b>Test Sample Related</b>						
Dipole Positioning	2	Normal	1.732050808	1	1.2	∞
Power & Power Drift	4.7	Normal	1.732050808	1	2.7	∞
<b>Phantom and Setup</b>						
Phantom uncertainty	4	Rectangular	1.732050808	1	2.3	∞
Liquid conductivity (target)	5	Rectangular	1.732050808	0.64	1.8	∞
Liquid conductivity (measured)	2.5	Normal	1	0.64	1.6	∞
Liquid permittivity (target)	5	Rectangular	1.732050808	0.6	1.7	∞
Liquid permittivity (measured)	2.5	Normal	1	0.6	1.5	∞
<b>Combined Standard Uncertainty</b>					<b>8.79</b>	
<b>Expanded Uncertainty (k=2)</b>					<b>17.57</b>	

Measurement Uncertainty Table in accordance with IEEE Standard 1528-2003 (see reference [5])

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102


## 16.0 REFERENCES

- [1] Federal Communications Commission, "Radiofrequency radiation exposure evaluation: portable devices", Rule Part 47 CFR §2.1093: 1999.
- [2] Health Canada, "Limits of Human Exposure to Radiofrequency Electromagnetic Fields in the Frequency Range from 3 kHz to 300 GHz", Safety Code 6.
- [3] Federal Communications Commission, "Evaluating Compliance with FCC Guidelines for Human Exposure to Radio frequency Electromagnetic Fields", OET Bulletin 65, Supplement C (Edition 01-01), FCC, Washington, D.C.: June 2001.
- [4] Industry Canada, "Evaluation Procedure for Mobile and Portable Radio Transmitters with respect to Health Canada's Safety Code 6 for Exposure of Humans to Radio Frequency Fields", Radio Standards Specification RSS-102 Issue 1 (Provisional): September 1999.
- [5] IEEE Standard 1528-2003, "Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques": December 2003.



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005	
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1	
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

## APPENDIX A - SAR MEASUREMENT DATA

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc.      This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.      17 of 49				

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Right Ear - Cheek/Touch Position - CS55 Headset (Long Boom)

**DUT: Plantronics Inc. Model: CS55 Headset; Type: Wireless Office Headset System; Serial: R790922876**

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

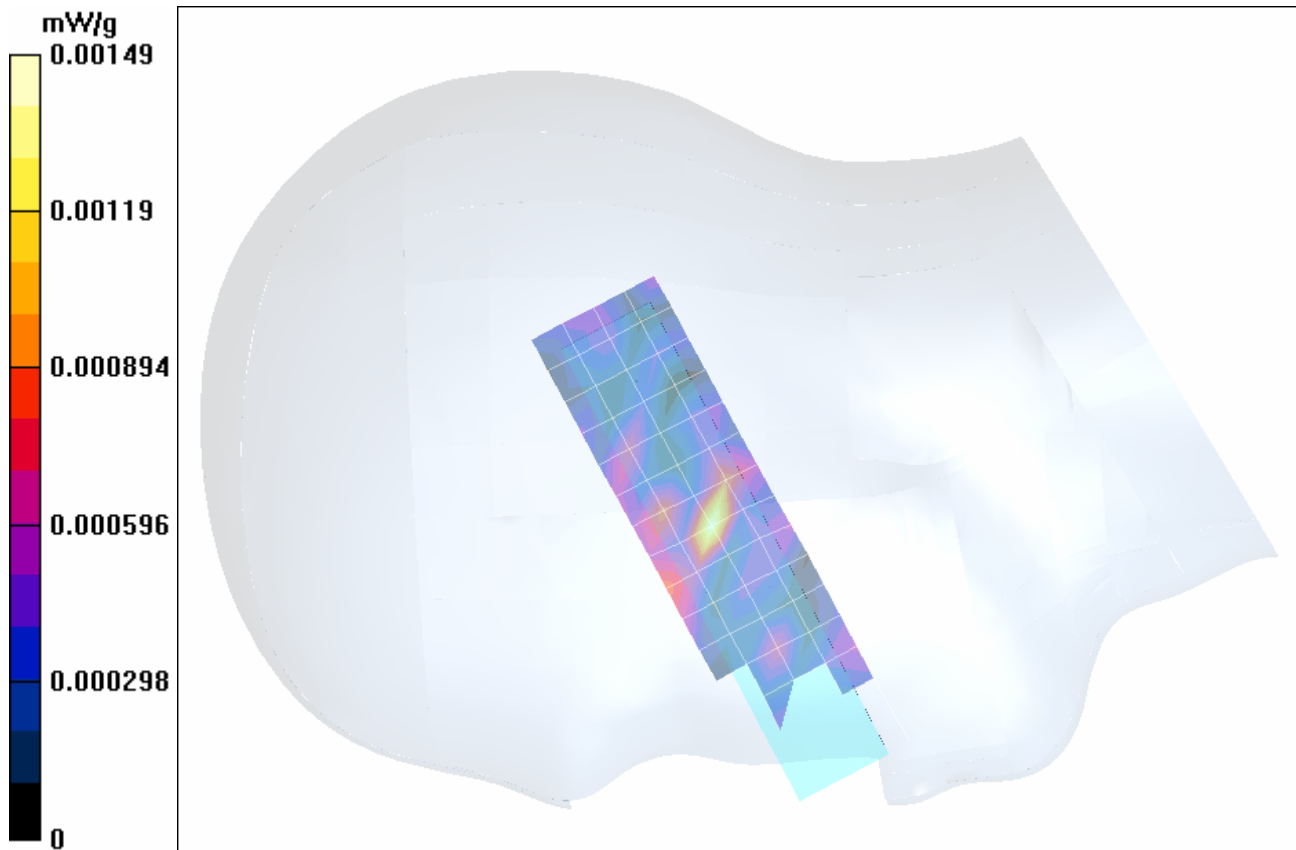
Communication System: TDMA  
 3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)  
 RF Output Power: 8.82 dBm (Peak Conducted)  
 Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05  
 Medium: HSL1925 ( $\sigma = 1.42 \text{ mho/m}$ ;  $\epsilon_r = 38.2$ ;  $\rho = 1000 \text{ kg/m}^3$ )

- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglass; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

### Head SAR - Right Ear - Cheek/Touch Position/Area Scan (5x16x1):

Measurement grid: dx=10mm, dy=10mm

**Maximum value of SAR (measured) = 0.001495 mW/g**



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Right Ear - Cheek/Touch Position - CS55 Micro Headset (Short Boom)

DUT: Plantronics Inc. Model: CS55 Micro Headset; Type: Wireless Office Headset System; Serial: R79O058767

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

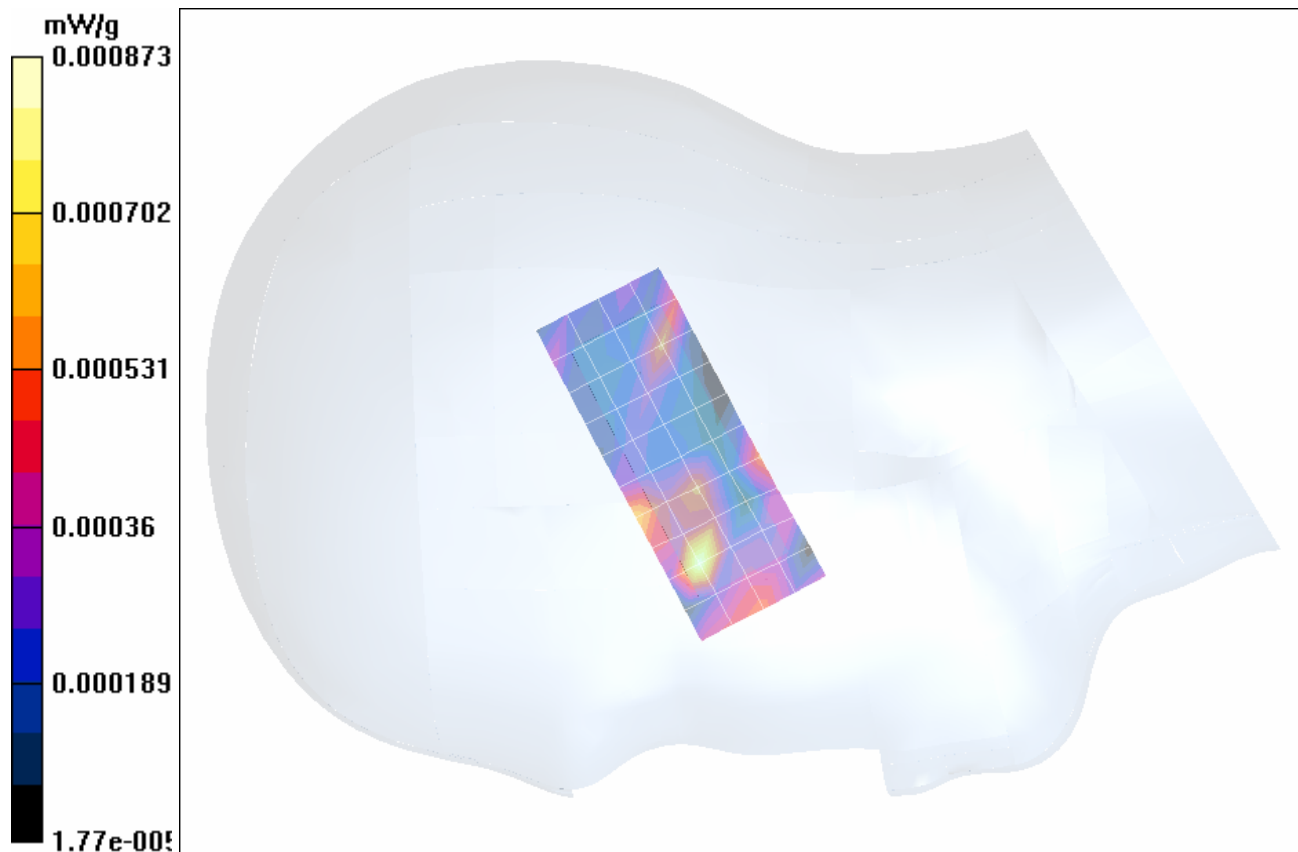
Communication System: TDMA  
 3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)  
 RF Output Power: 8.68 dBm (Peak Conducted)  
 Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05  
 Medium: HSL1925 ( $\sigma = 1.42 \text{ mho/m}$ ;  $\epsilon_r = 38.2$ ;  $\rho = 1000 \text{ kg/m}^3$ )

- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fibreglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

### Head SAR - Right Ear - Cheek/Touch Position/Area Scan (5x11x1):

Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (measured) = 0.000873 mW/g



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Right Ear - Tilt Position (15°) - CS55 Headset (Long Boom)

**DUT: Plantronics Inc. Model: CS55 Headset; Type: Wireless Office Headset System; Serial: R790922876**

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

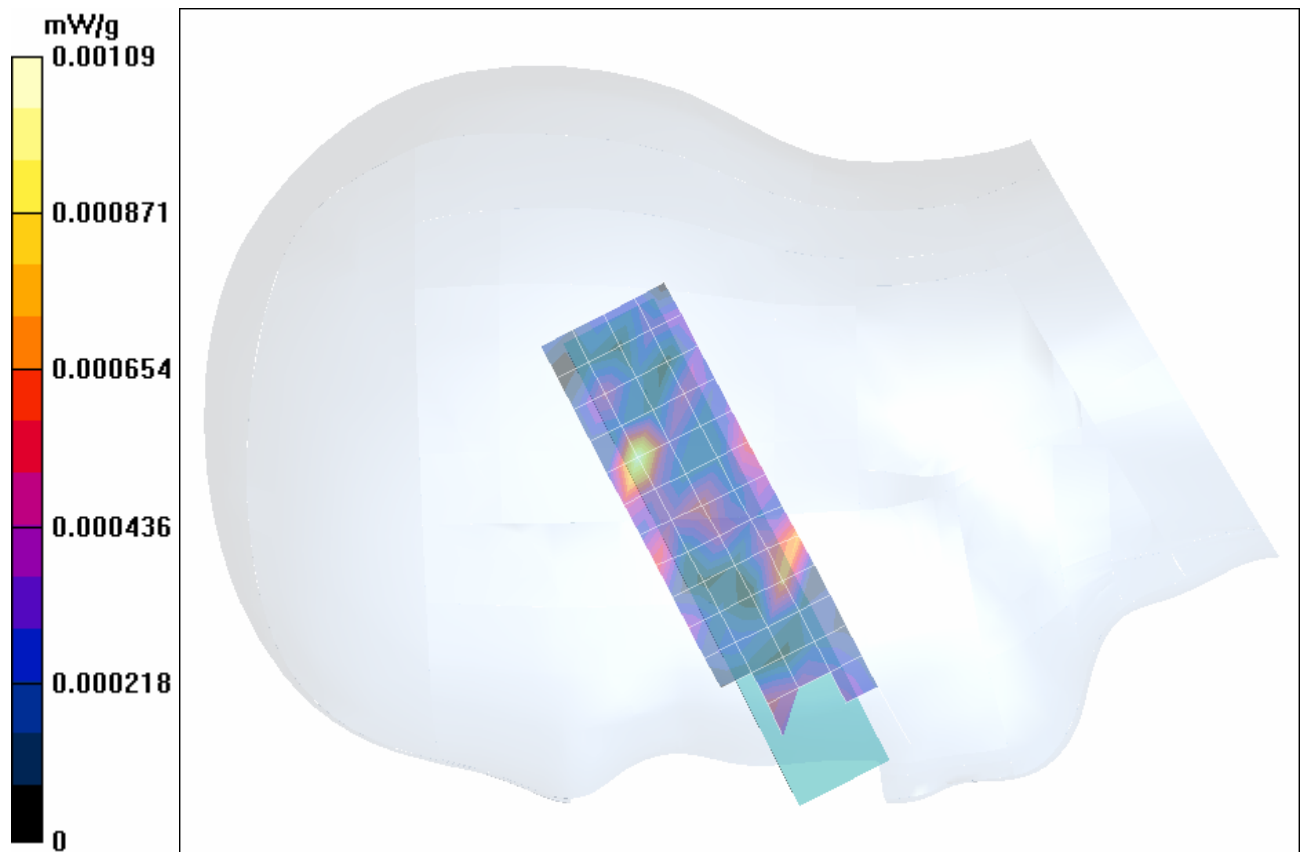
Communication System: TDMA  
 3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)  
 RF Output Power: 8.82 dBm (Peak Conducted)  
 Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05  
 Medium: HSL1925 ( $\sigma = 1.42 \text{ mho/m}$ ;  $\epsilon_r = 38.2$ ;  $\rho = 1000 \text{ kg/m}^3$ )


- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fibreglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

### Head SAR - Right Ear - Tilt Position (15°)/Area Scan (5x16x1):

Measurement grid: dx=10mm, dy=10mm

**Maximum value of SAR (measured) = 0.001089 mW/g**



Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Headset	
Model(s):	CS55 Headset, CS55 Micro Headset	Tx Frequency Range:	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 20 of 49				

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Right Ear - Tilt Position (15°) - CS55 Micro Headset (Short Boom)

DUT: Plantronics Inc. Model: CS55 Micro Headset; Type: Wireless Office Headset System; Serial: R790058767

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

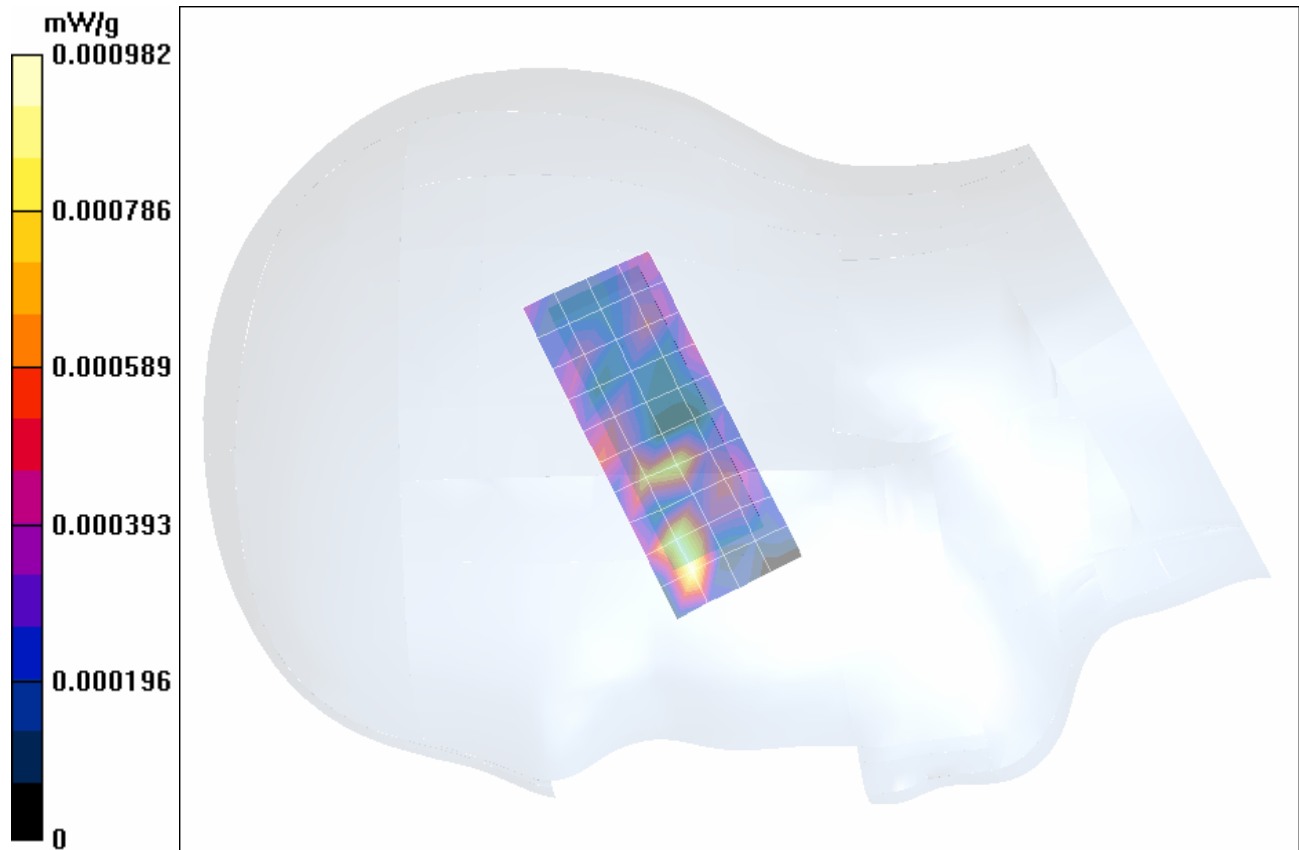
Communication System: TDMA  
 3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)  
 RF Output Power: 8.68 dBm (Peak Conducted)  
 Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05  
 Medium: HSL1925 ( $\sigma = 1.42 \text{ mho/m}$ ;  $\epsilon_r = 38.2$ ;  $\rho = 1000 \text{ kg/m}^3$ )

- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fibreglas; Serial: 1033
- Measurement SW: DASy4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

#### Head SAR - Right Ear - Tilt Position (15°)/Area Scan (5x11x1):

Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (measured) = 0.000982 mW/g



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Left Ear - Cheek/Touch Position - CS55 Headset (Long Boom)

DUT: Plantronics Inc. Model: CS55 Headset; Type: Wireless Office Headset System; Serial: R790922876

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

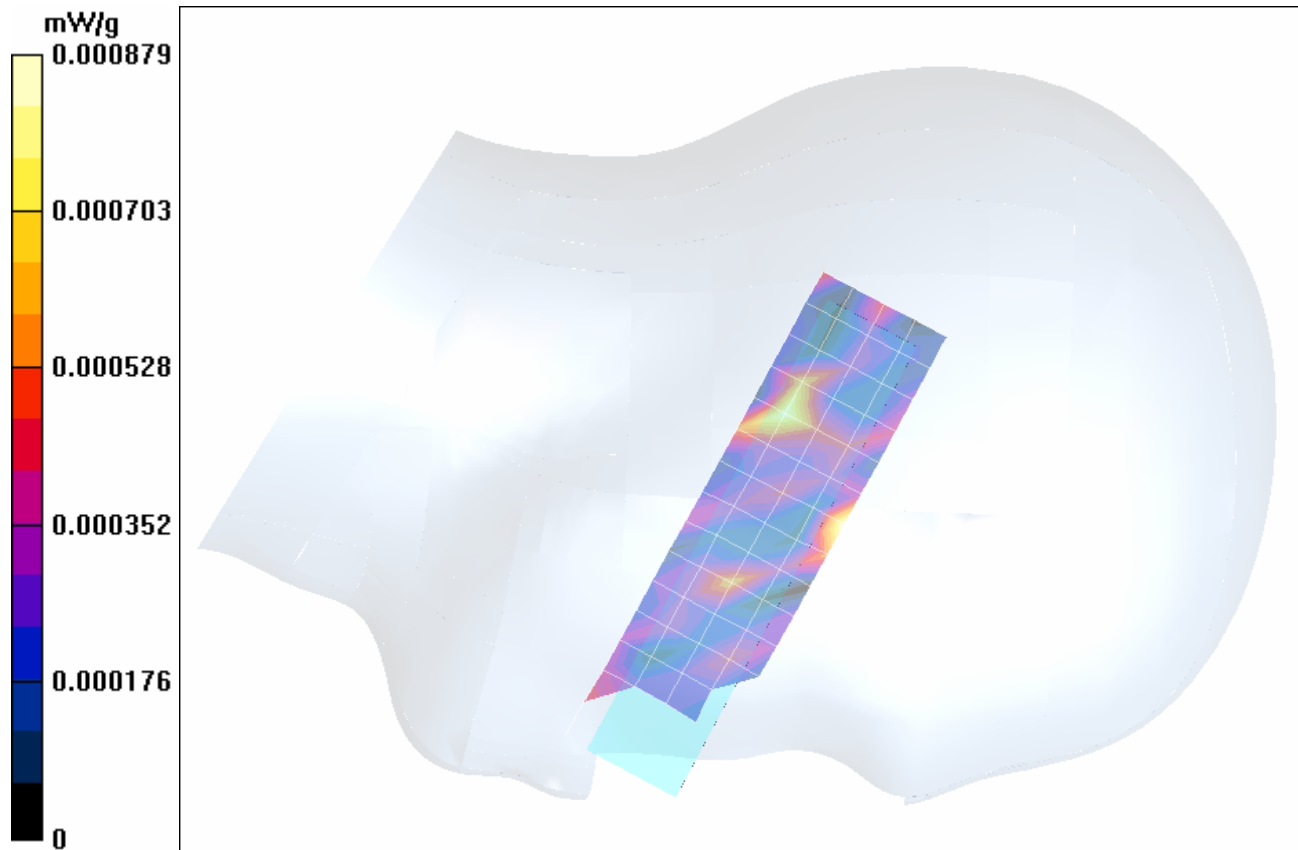
Communication System: TDMA  
 3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)  
 RF Output Power: 8.82 dBm (Peak Conducted)  
 Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05  
 Medium: HSL1925 ( $\sigma = 1.42$  mho/m;  $\epsilon_r = 38.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>)

- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

### Head SAR - Left Ear - Cheek/Touch Position/Area Scan (5x16x1):

Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (measured) = 0.000879 mW/g



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Left Ear - Cheek/Touch Position - CS55 Micro Headset (Short Boom)

**DUT: Plantronics Inc. Model: CS55 Micro Headset; Type: Wireless Office Headset System; Serial: R79O058767**

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

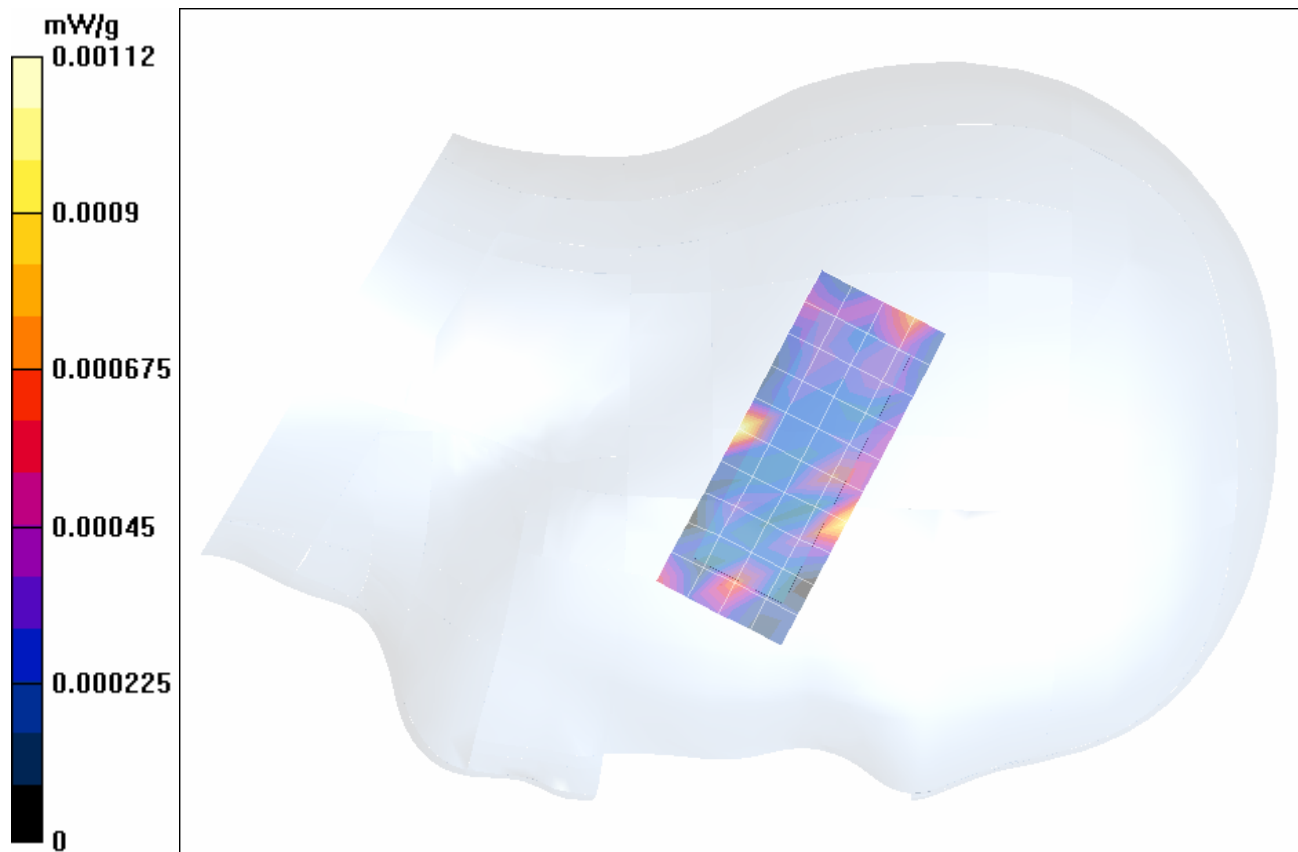
Communication System: TDMA  
 3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)  
 RF Output Power: 8.68 dBm (Peak Conducted)  
 Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05  
 Medium: HSL1925 ( $\sigma = 1.42 \text{ mho/m}$ ;  $\epsilon_r = 38.2$ ;  $\rho = 1000 \text{ kg/m}^3$ )

- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

### Head SAR - Left Ear - Cheek/Touch Position/Area Scan (5x11x1):

Measurement grid: dx=10mm, dy=10mm

**Maximum value of SAR (measured) = 0.001125 mW/g**



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Left Ear - Tilt Position (15°) - CS55 Headset (Long Boom)

**DUT: Plantronics Inc. Model: CS55 Headset; Type: Wireless Office Headset System; Serial: R790922876**

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

Communication System: TDMA

3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)

RF Output Power: 8.82 dBm (Peak Conducted)

Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05

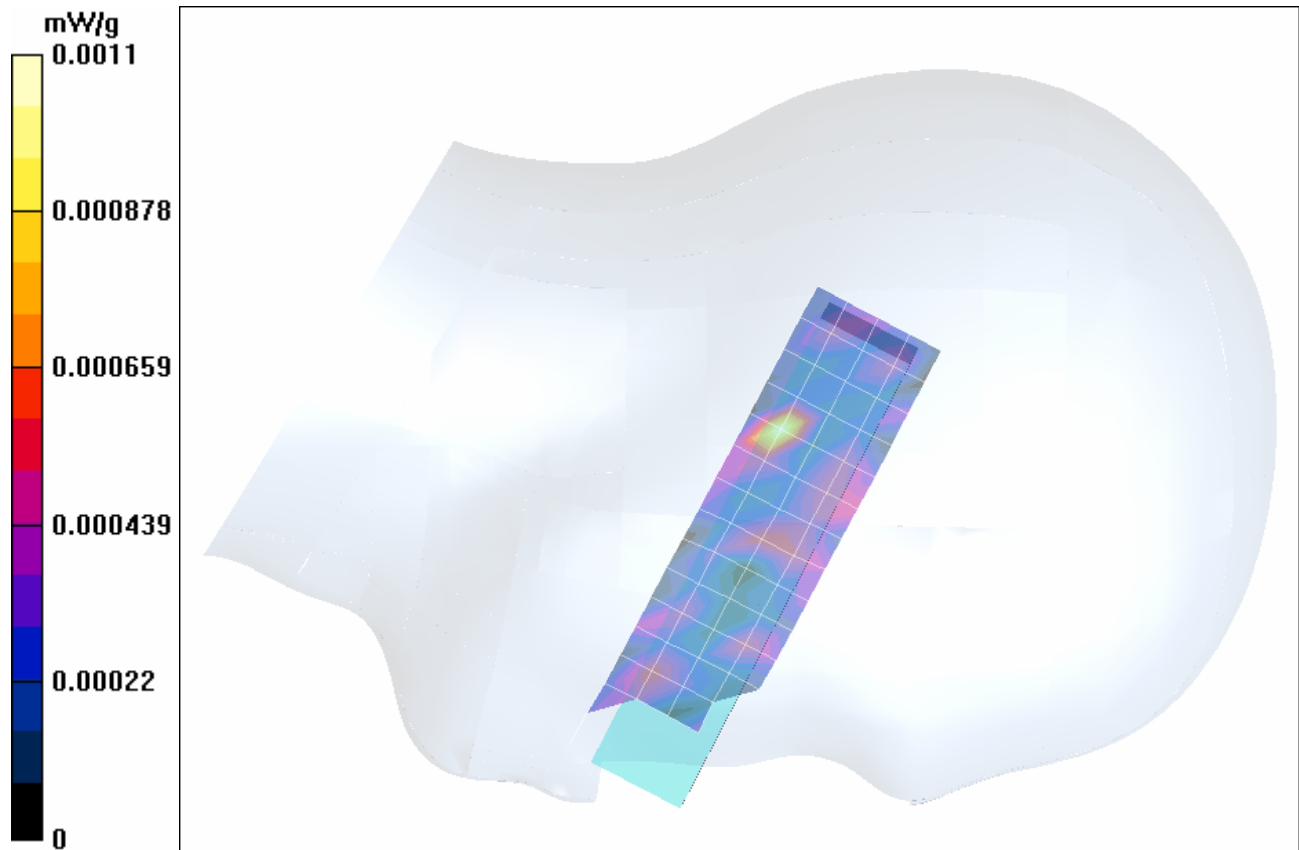
Medium: HSL1925 ( $\sigma = 1.42$  mho/m;  $\epsilon_r = 38.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>)

- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fibreglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

#### Head SAR - Left Ear - Tilt Position (15°/Area Scan (5x16x1):

Measurement grid: dx=10mm, dy=10mm

**Maximum value of SAR (measured) = 0.001098 mW/g**





Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### Head SAR - Left Ear - Tilt Position (15°) - CS55 Micro Headset (Short Boom)

DUT: Plantronics Inc. Model: CS55 Micro Headset; Type: Wireless Office Headset System; Serial: R790058767

Ambient Temp: 24.5 °C; Fluid Temp: 22.4 °C; Barometric Pressure: 102.1 kPa; Humidity: 31%

Communication System: TDMA

3.75V, 190mAh Lithium-ion Polymer Battery (P/N: 65358-01)

RF Output Power: 8.68 dBm (Peak Conducted)

Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05

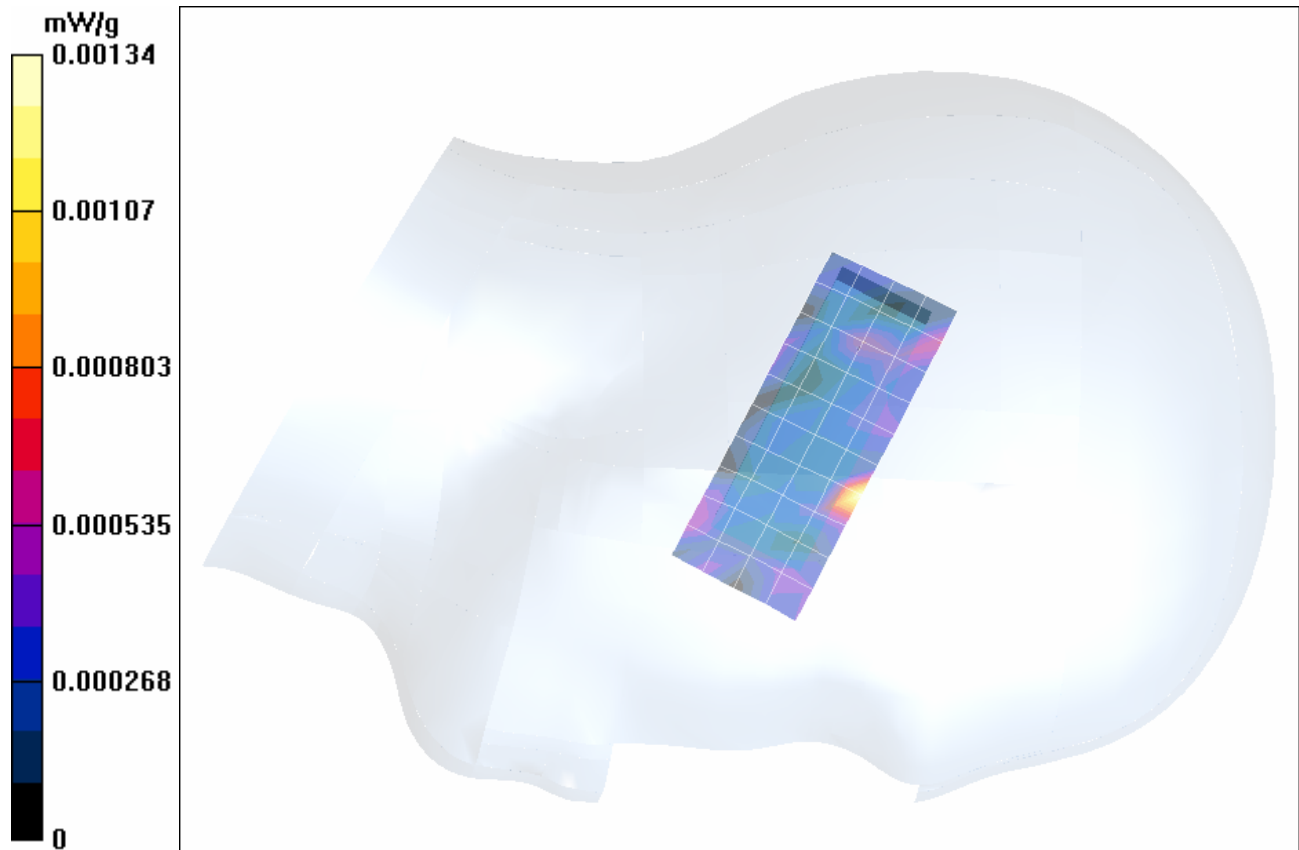
Medium: HSL1925 ( $\sigma = 1.42 \text{ mho/m}$ ;  $\epsilon_r = 38.2$ ;  $\rho = 1000 \text{ kg/m}^3$ )

- Probe: ET3DV6 - SN1387; ConvF(5, 5, 5); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fibreglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

#### Head SAR - Left Ear - Tilt Position (15°)/Area Scan (5x11x1):

Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (measured) = 0.001338 mW/g



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093
			IC RSS-102


**Fluid Depth (>15cm)**



**Right Head Section**




**Left Head Section**

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 26 of 49				

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005	
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1	
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

## APPENDIX B - SYSTEM PERFORMANCE CHECK DATA

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset		
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz		
2005 Celltech Labs Inc.		This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.			27 of 49

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

Date Tested: 08/02/2005

### System Performance Check (Brain) - 1900 MHz Dipole

**DUT: Dipole 1900 MHz; Model: D1900V2; Type: System Performance Check; Serial: 151; Calibrated: 06/17/2005**

Ambient Temp: 24.6 °C; Fluid Temp: 23.3 °C; Barometric Pressure: 102.2 kPa; Humidity: 30%

Communication System: CW  
 Forward Conducted Power: 250 mW  
 Frequency: 1900 MHz; Duty Cycle: 1:1  
 Medium: HSL1900 ( $\sigma = 1.43 \text{ mho/m}$ ;  $\epsilon_r = 38.2$ ;  $\rho = 1000 \text{ kg/m}^3$ )

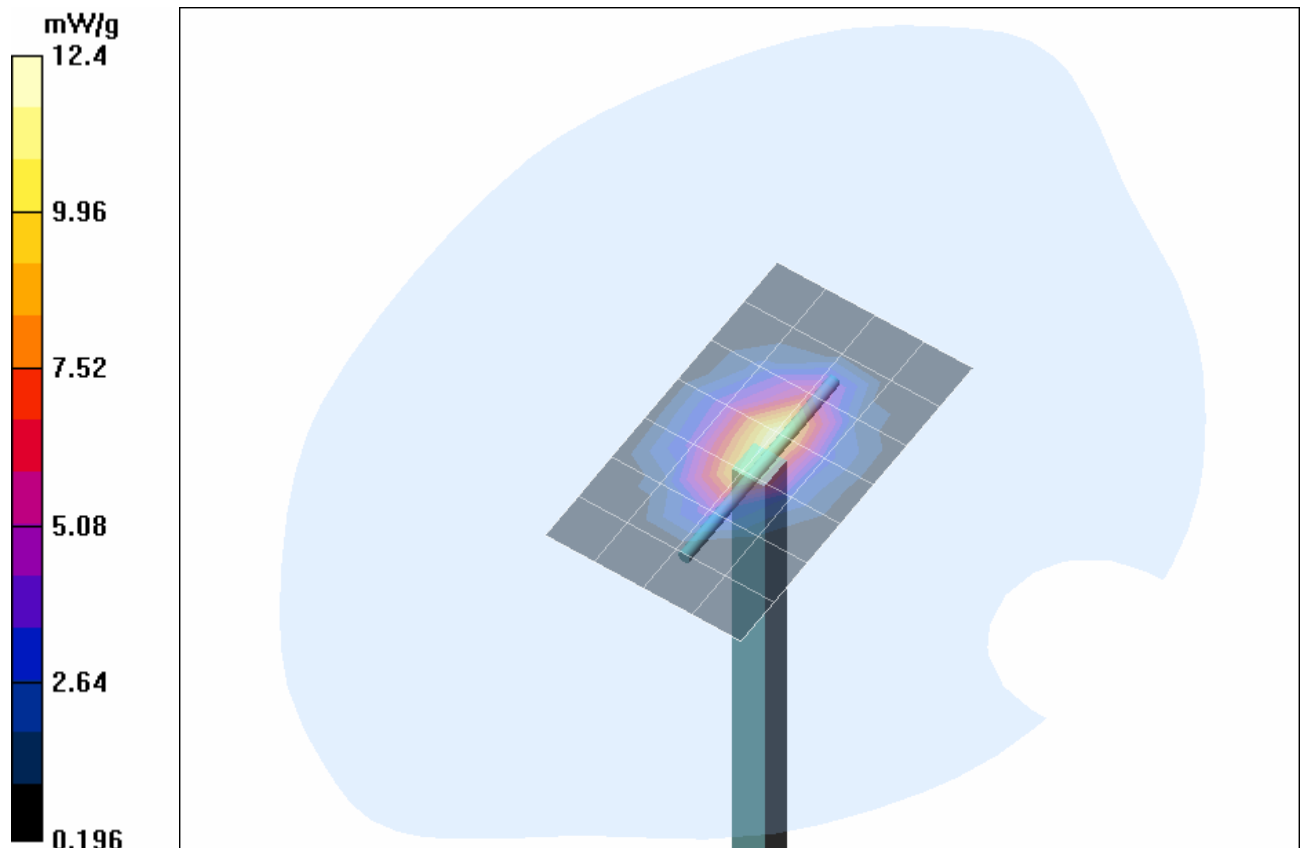
- Probe: ET3DV6 - SN1387; ConvF(5.18, 5.18, 5.18); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146


#### 1900 MHz Dipole - System Performance Check/Area Scan (5x8x1):

Measurement grid: dx=15mm, dy=15mm

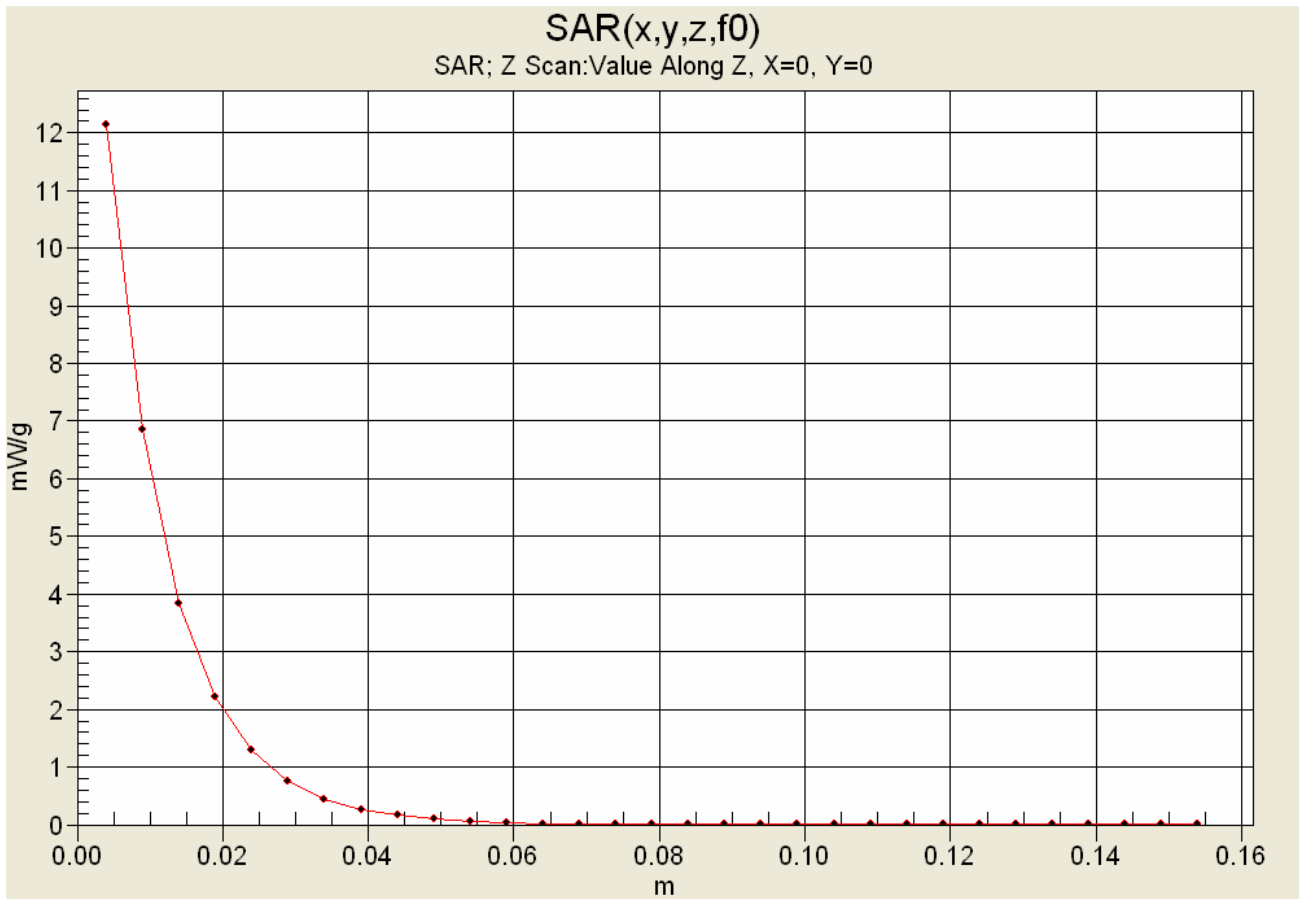
#### 1900 MHz Dipole - System Performance Check/Zoom Scan (7x7x7)/Cube 0:

Measurement grid: dx=5mm, dy=5mm, dz=5mm  
 Reference Value = 98.2 V/m; Power Drift = -0.039 dB  
 Peak SAR (extrapolated) = 19.6 W/kg  
**SAR(1 g) = 10.9 mW/g; SAR(10 g) = 5.64 mW/g**




Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Headset	
Model(s):	CS55 Headset, CS55 Micro Headset	Tx Frequency Range:	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 28 of 49				

### Z-Axis Scan



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## APPENDIX C - MEASURED FLUID DIELECTRIC PARAMETERS

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset		
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz		
2005 Celltech Labs Inc.		This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.			30 of 49

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

### 1925 MHz DUT Evaluation (Head)

```

*****
Celltech Labs Inc.
Test Result for UIM Dielectric Parameter
Tue 02/Aug/2005
Freq      Frequency(GHz)
FCC_eH    FCC OET 65 Supplement C (June 2001) Limits for Head Epsilon
FCC_sH    FCC OET 65 Supplement C (June 2001) Limits for Head Sigma
Test_e    Epsilon of UIM
Test_s    Sigma of UIM

```

```

*****
Freq      FCC_eH  FCC_sH  Test_e  Test_s
1.8250    40.00   1.40   38.55   1.34
1.8350    40.00   1.40   38.48   1.34
1.8450    40.00   1.40   38.46   1.35
1.8550    40.00   1.40   38.41   1.36
1.8650    40.00   1.40   38.39   1.37
1.8750    40.00   1.40   38.24   1.37
1.8850    40.00   1.40   38.31   1.38
1.8950    40.00   1.40   38.28   1.39
1.9050    40.00   1.40   38.27   1.40
1.9150    40.00   1.40   38.29   1.41
1.9250    40.00   1.40   38.16   1.42
1.9350    40.00   1.40   38.13   1.43
1.9450    40.00   1.40   38.14   1.45
1.9550    40.00   1.40   38.17   1.45
1.9650    40.00   1.40   38.13   1.46
1.9750    40.00   1.40   38.10   1.48
1.9850    40.00   1.40   38.07   1.48
1.9950    40.00   1.40   38.02   1.49
2.0050    39.99   1.40   38.03   1.50
2.0150    39.97   1.41   37.97   1.52
2.0250    39.96   1.42   37.82   1.53

```

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

### 1900 MHz System Performance Check (Brain)

\*\*\*\*\*

Celltech Labs Inc.

Test Result for UIM Dielectric Parameter

Tue 02/Aug/2005

Freq Frequency (GHz)

FCC\_eH FCC OET 65 Supplement C (June 2001) Limits for Head Epsilon


FCC\_sH FCC OET 65 Supplement C (June 2001) Limits for Head Sigma

Test\_e Epsilon of UIM

Test\_s Sigma of UIM

\*\*\*\*\*


Freq	FCC_eH	FCC_sH	Test_e	Test_s
1.8000	40.00	1.40	38.26	1.35
1.8100	40.00	1.40	38.02	1.36
1.8200	40.00	1.40	38.22	1.37
1.8300	40.00	1.40	38.12	1.39
1.8400	40.00	1.40	37.90	1.40
1.8500	40.00	1.40	38.20	1.40
1.8600	40.00	1.40	38.03	1.41
1.8700	40.00	1.40	38.11	1.44
1.8800	40.00	1.40	38.06	1.42
1.8900	40.00	1.40	37.91	1.44
1.9000	40.00	1.40	38.15	1.43
1.9100	40.00	1.40	38.15	1.44
1.9200	40.00	1.40	37.97	1.46
1.9300	40.00	1.40	37.70	1.48
1.9400	40.00	1.40	37.68	1.51
1.9500	40.00	1.40	37.90	1.50
1.9600	40.00	1.40	37.79	1.51
1.9700	40.00	1.40	37.57	1.51
1.9800	40.00	1.40	37.82	1.53
1.9900	40.00	1.40	37.69	1.54
2.0000	40.00	1.40	37.66	1.54

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Headset		
Model(s):	CS55 Headset, CS55 Micro Headset	Tx Frequency Range:	1921.536 - 1928.448 MHz		
2005 Celltech Labs Inc.		This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.			32 of 49



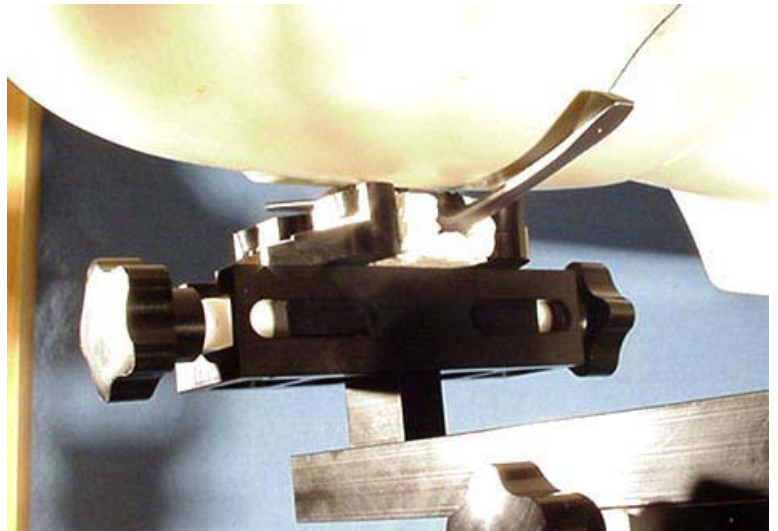
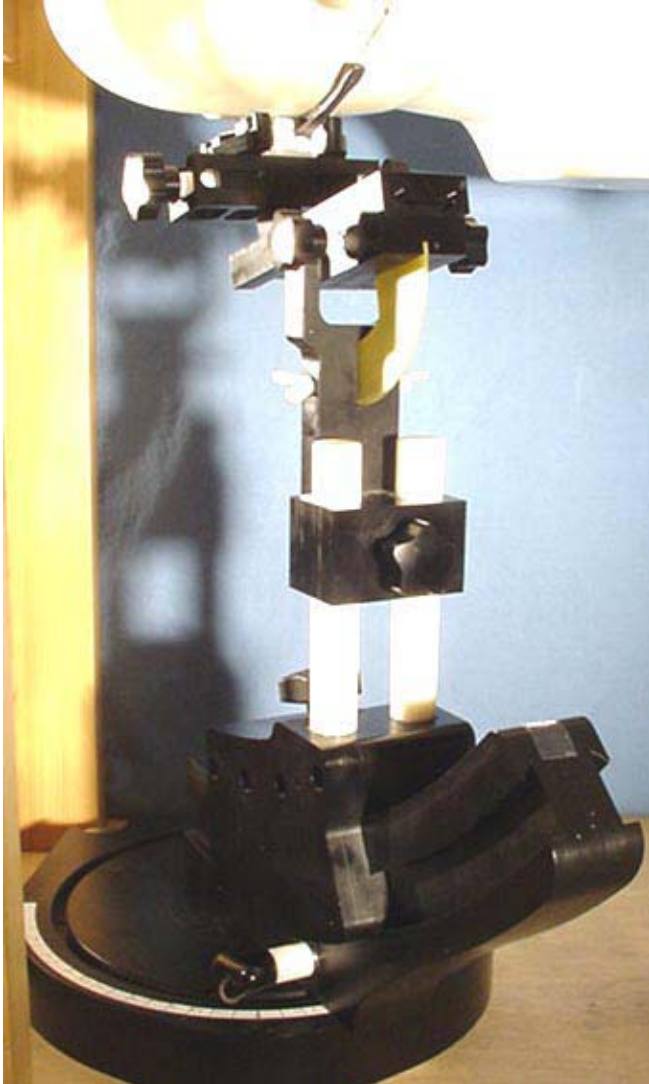
Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## APPENDIX D - SAR TEST SETUP & DUT PHOTOGRAPHS

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset		
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz		
2005 Celltech Labs Inc.		This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.			33 of 49

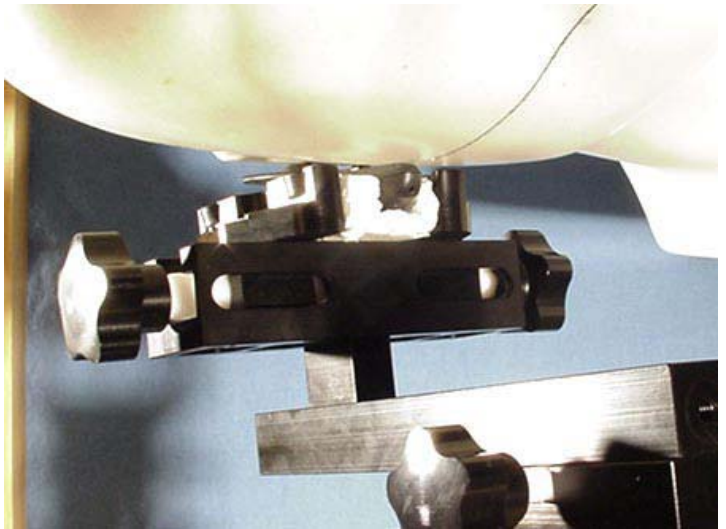
Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Right Head Section / Cheek-Touch Position  
 CS55 Headset (Long Boom)



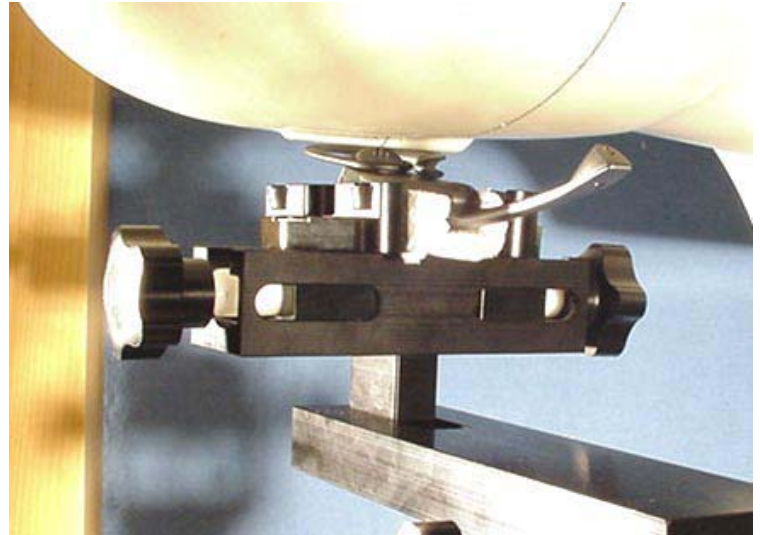
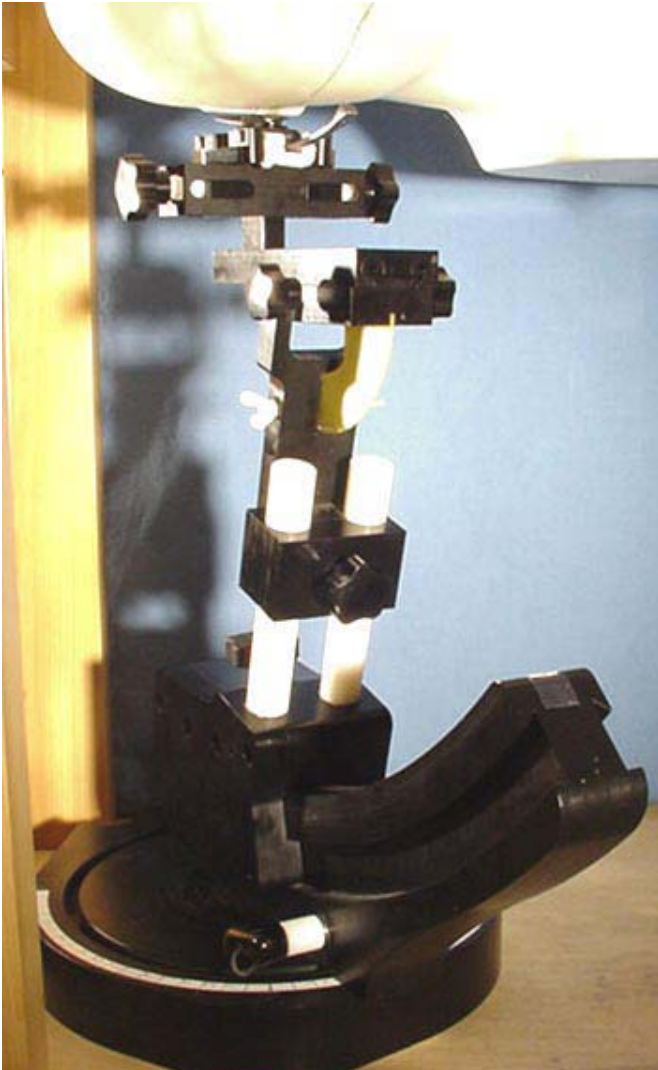
Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Right Head Section / Cheek-Touch Position  
 CS55 Micro Headset (Short Boom)



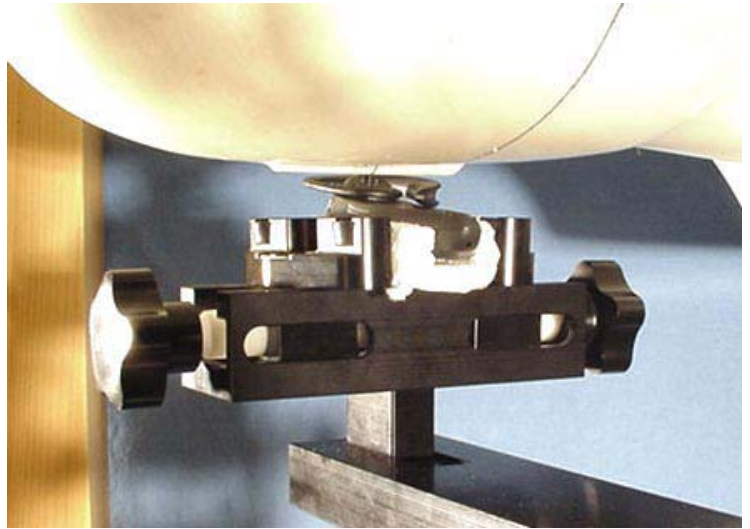
Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Right Head Section / Ear-Tilt Position (15°)  
 CS55 Headset (Long Boom)



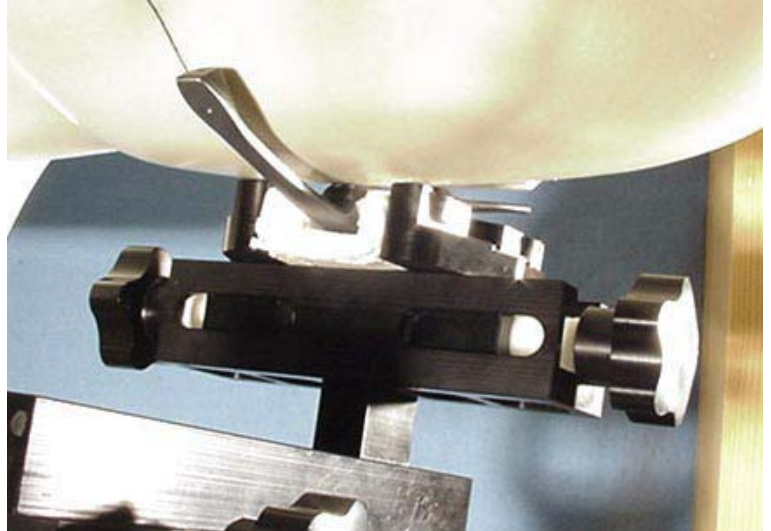
Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Right Head Section / Ear-Tilt Position (15°)  
 CS55 Micro Headset (Short Boom)



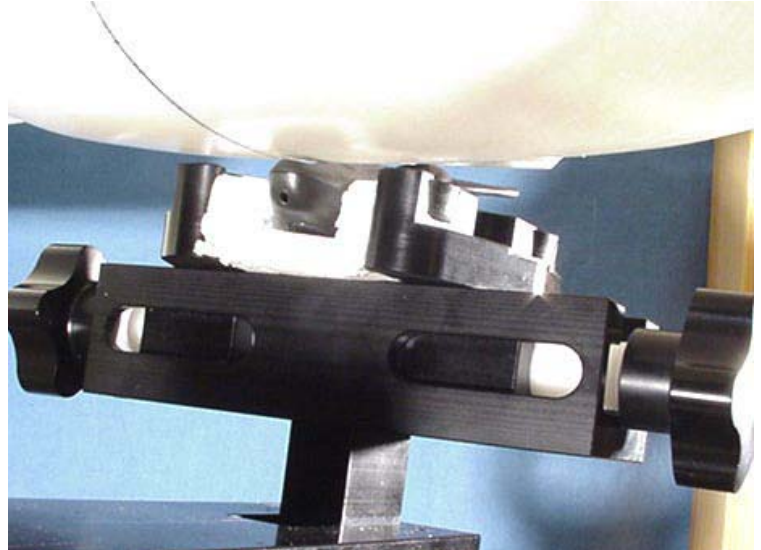
Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Left Head Section / Cheek-Touch Position  
 CS55 Headset (Long Boom)



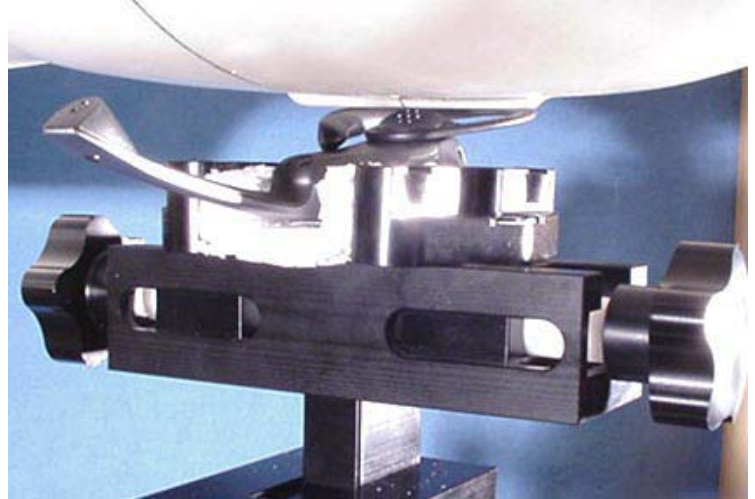
Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Left Head Section / Cheek-Touch Position  
 CS55 Micro Headset (Short Boom)



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

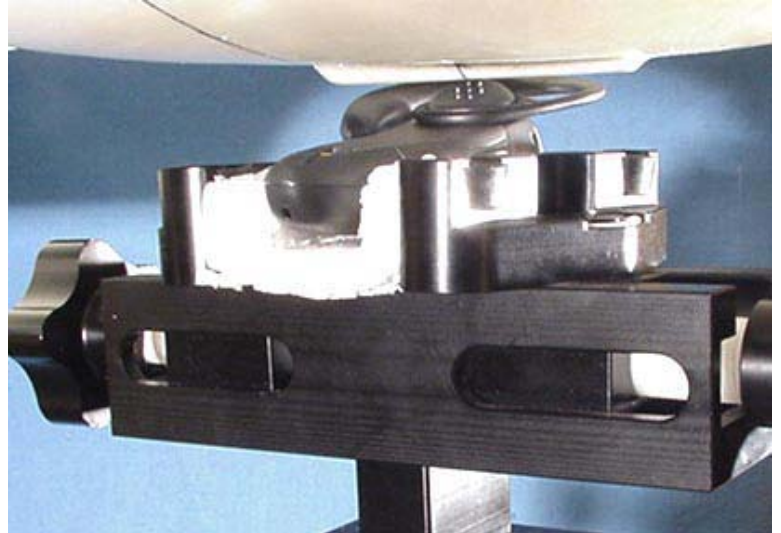
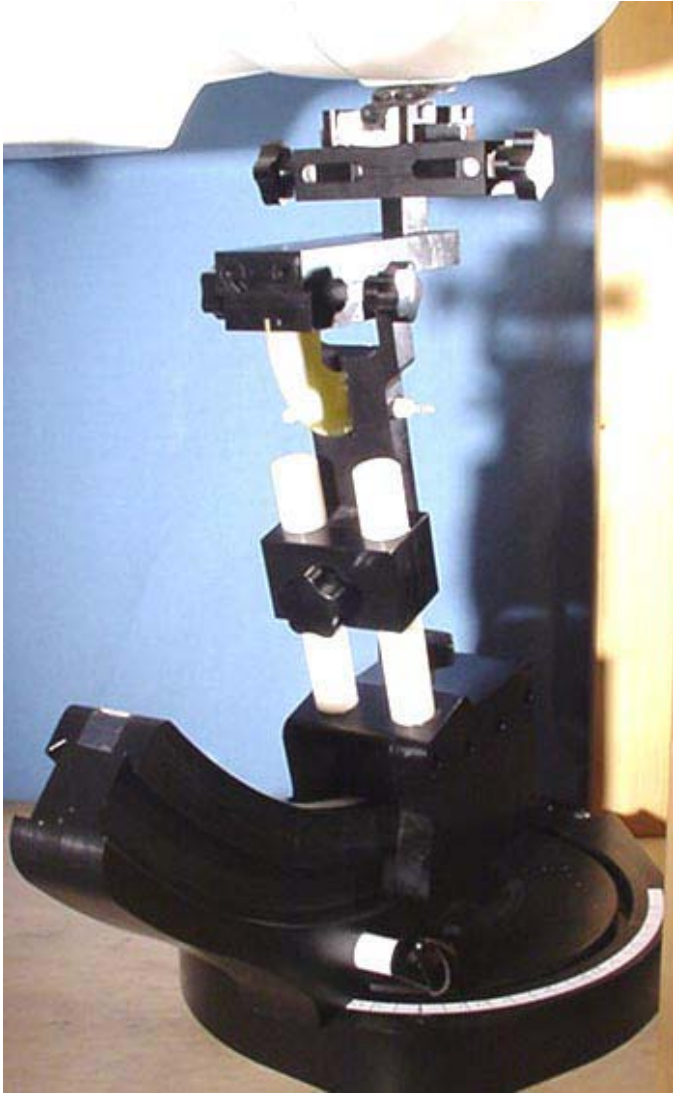
**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Left Head Section / Ear-Tilt Position (15°)  
 CS55 Headset (Long Boom)





Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**HEAD SAR TEST SETUP PHOTOGRAPHS**  
 Left Head Section / Ear-Tilt Position (15°)  
 CS55 Micro Headset (Short Boom)



Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**DUT PHOTOGRAPHS**

**CS55 Headset (Long Boom)**

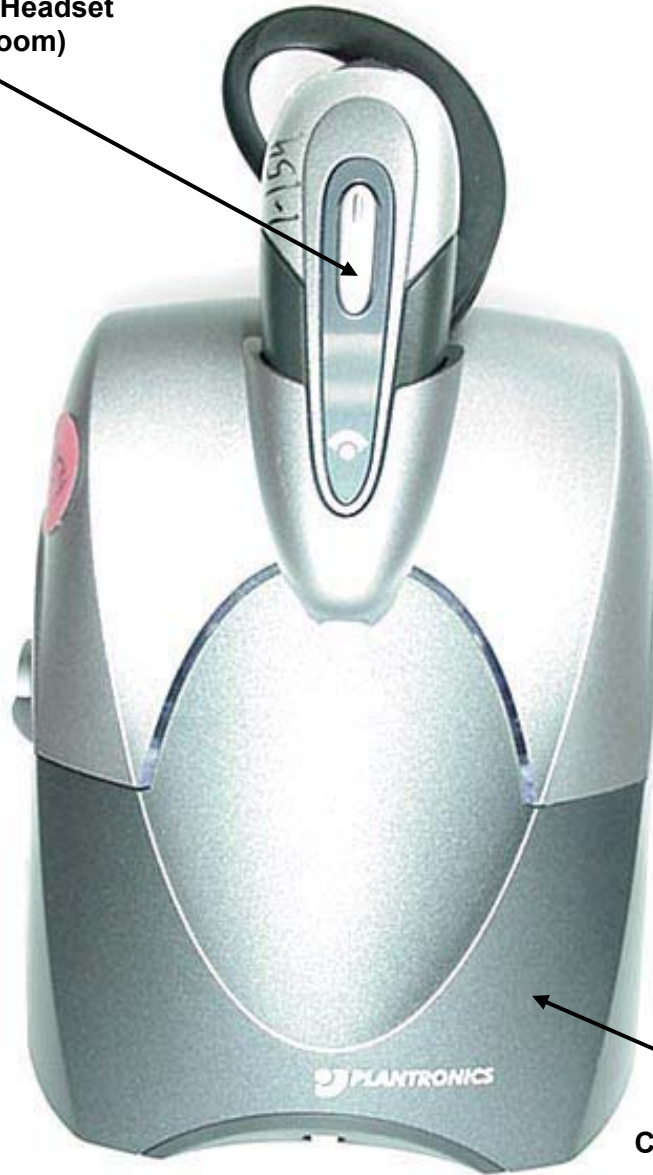


**CS55 Base Unit**

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

**DUT PHOTOGRAPHS**

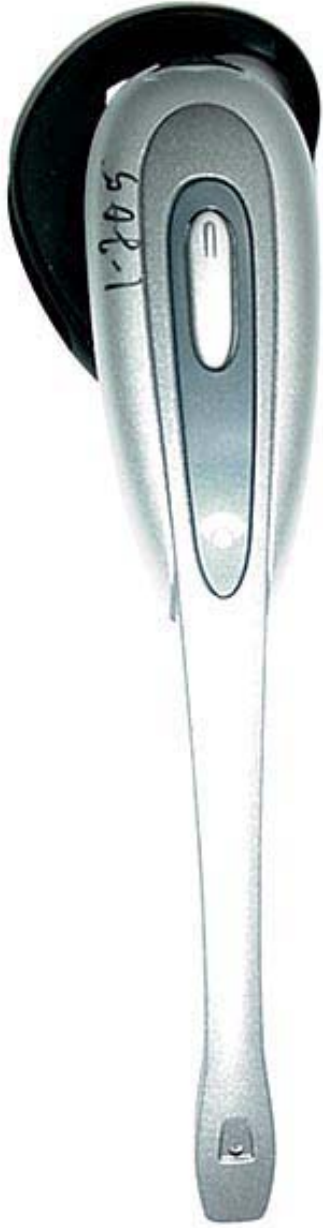
**CS55 Micro Headset  
(Short Boom)**



**CS55 Micro Base Unit**

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## DUT PHOTOGRAPHS



**CS55 Headset (Long Boom)**



**CS55 Micro Headset (Short Boom)**

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102


**DUT PHOTOGRAPHS**



**CS55 Headset (Long Boom)**



**CS55 Micro Headset (Short Boom)**

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc.      This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.      45 of 49				

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102


## DUT PHOTOGRAPHS



**CS55 Headset (Long Boom)**  
Battery Compartment for Lithium-ion Polymer Battery




**CS55 Micro Headset (Short Boom)**  
Battery Compartment for Lithium-ion Polymer Battery

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc.      This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc.      46 of 49				

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## APPENDIX E - SYSTEM VALIDATION

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 47 of 49				

## 1900 MHz SYSTEM VALIDATION DIPOLE

Type:

**1900 MHz Validation Dipole**

Asset Number:

**00032**

Serial Number:

**151**

Place of Calibration:

**Celltech Labs Inc.**

Date of Calibration:

**June 17, 2005**

**Celltech Labs Inc. hereby certifies that this device has been calibrated on the date indicated above.**

Calibrated by:



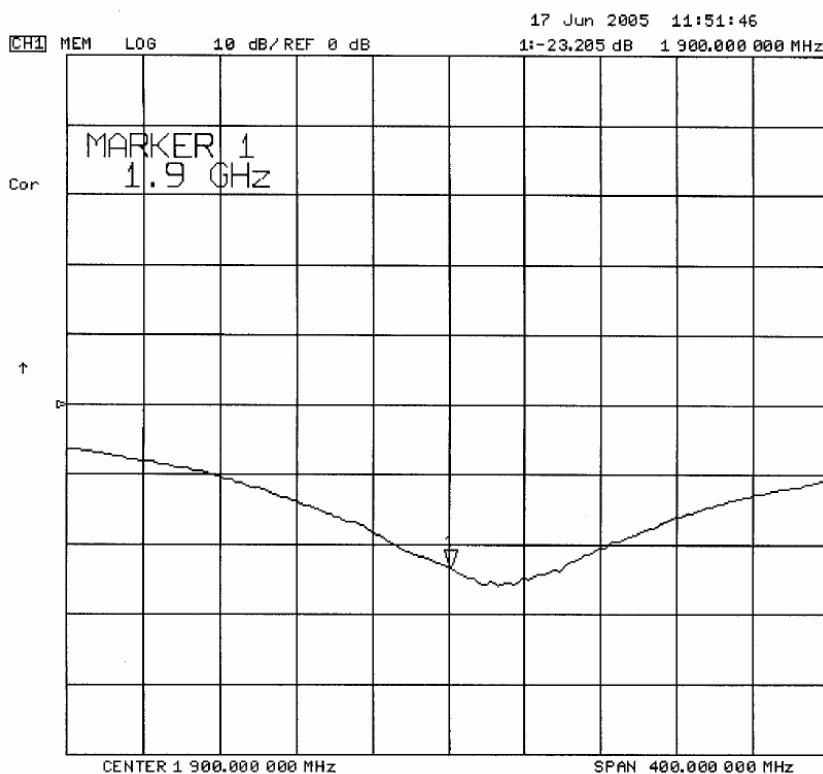
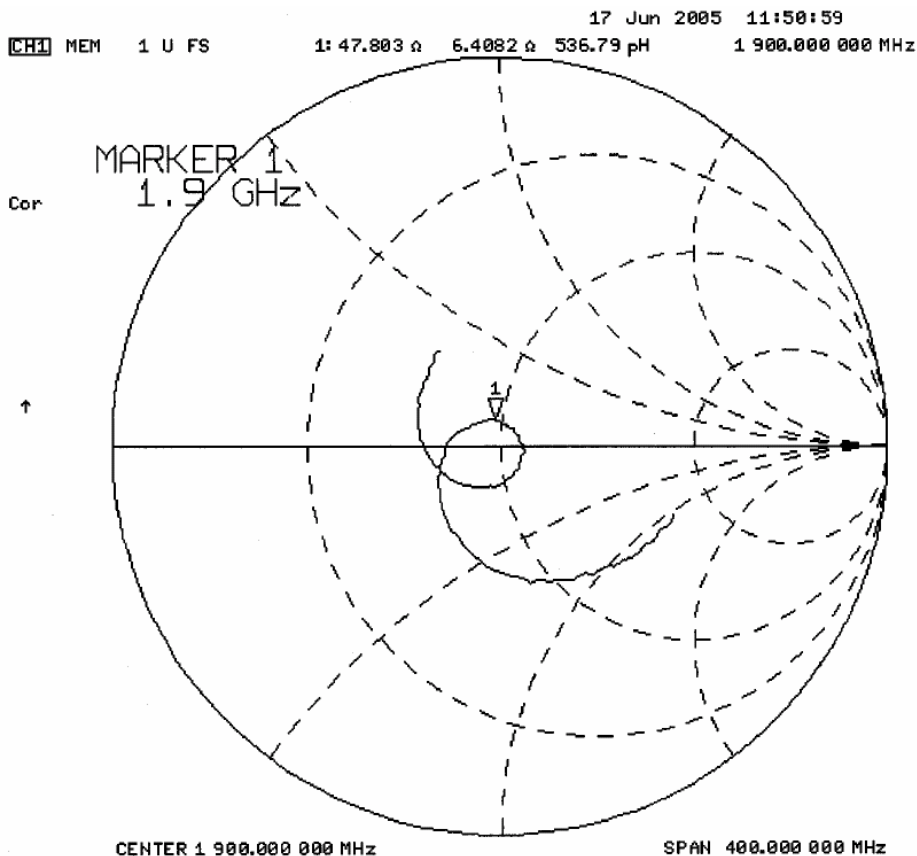
Approved by:







**2. Validation Dipole VSWR Data**



### 3. Validation Dipole Dimensions

Frequency (MHz)	L (mm)	h (mm)	d (mm)
300	420.0	250.0	6.2
450	288.0	167.0	6.2
835	161.0	89.8	3.6
900	149.0	83.3	3.6
1450	89.1	51.7	3.6
1800	72.0	41.7	3.6
1900	68.0	39.5	3.6
2000	64.5	37.5	3.6
2450	51.8	30.6	3.6
3000	41.5	25.0	3.6

### 4. Validation Phantom

The validation phantom is the SAM (Specific Anthropomorphic Mannequin) phantom manufactured by Schmid & Partner Engineering AG. The SAM phantom is a Fiberglass shell integrated in a wooden table. The shape of the shell corresponds to the phantom defined by SCC34-SC2. It enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region. A cover prevents evaporation of the liquid. Reference markings on the phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.

**Shell Thickness:** 2.0 ± 0.1 mm  
**Filling Volume:** Approx. 25 liters  
**Dimensions:** 50 cm (W) x 100 cm (L)

**5. 1900 MHz System Validation Setup**



**1900 MHz System Validation Setup**



## 6. Measurement Conditions

The SAM phantom was filled with 1900 MHz brain simulating tissue.

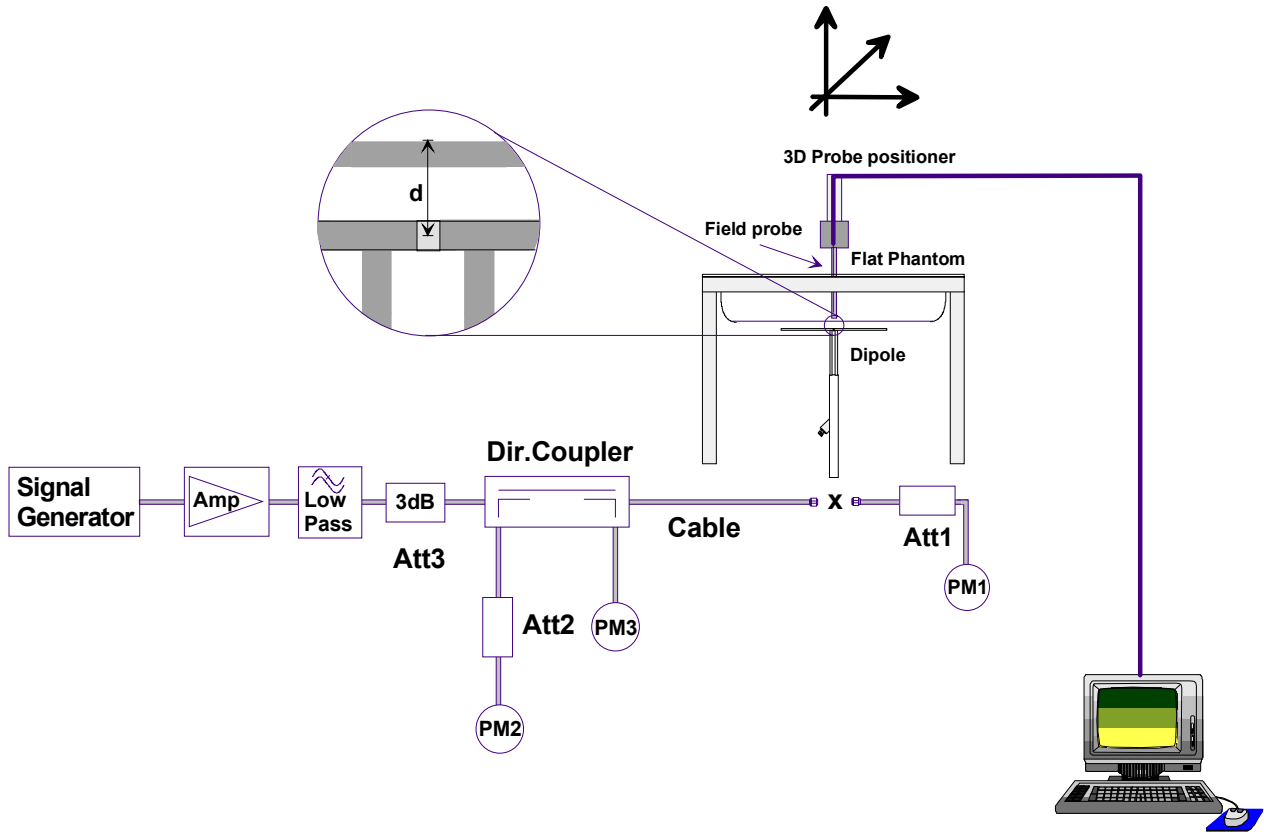
Relative Permittivity:	38.4
Conductivity:	1.40 mho/m
Ambient Temperature:	23.4 °C
Fluid Temperature:	22.7 °C
Fluid Depth:	≥ 15.0 cm
Barometric Pressure:	100.6 kPa
Humidity:	35%

The 1900 MHz tissue simulant consists of the following ingredients:

<b>Ingredient</b>	<b>Percentage by weight</b>
Water	55.85%
Glycol	44.00%
Salt	0.15%
Target Dielectric Parameters at 22 °C	$\epsilon_r = 40.0$ $\sigma = 1.40 \text{ S/m}$

## 7. SAR Measurement

The SAR measurement was performed with the E-field probe in mechanical detection mode only. The setup and determination of the forward power into the dipole was performed using the following procedures.



First the power meter PM1 (including attenuator Att1) is connected to the cable to measure the forward power at the location of the dipole connector (X). The signal generator is adjusted for the desired forward power at the dipole connector (taking into account the attenuation of Att1) as read by power meter PM2. After connecting the cable to the dipole, the signal generator is readjusted for the same reading at power meter PM2. If the signal generator does not allow adjustment in 0.01dB steps, the remaining difference at PM2 must be taken into consideration. PM3 records the reflected power from the dipole to ensure that the value is not changed from the previous value. The reflected power should be 50dB below the forward power.

### 8. Validation Dipole SAR Test Results

Ten SAR measurements were performed in order to achieve repeatability and to establish an average target value.

Validation Measurement	SAR @ 0.25W Input averaged over 1g	SAR @ 1W Input averaged over 1g	SAR @ 0.25W Input averaged over 10g	SAR @ 1W Input averaged over 10g	Peak SAR @ 0.25W Input
Test 1	9.97	39.88	5.20	20.80	17.7
Test 2	10.0	40.00	5.19	20.76	17.9
Test 3	10.1	40.40	5.21	20.84	18.1
Test 4	9.98	39.92	5.20	20.80	17.8
Test 5	9.96	39.84	5.19	20.76	17.7
Test 6	9.99	39.96	5.18	20.72	17.9
Test 7	9.89	39.56	5.16	20.64	17.5
Test 8	9.95	39.80	5.19	20.76	17.6
Test 9	9.96	39.84	5.20	20.80	17.6
Test 10	9.92	39.68	5.19	20.76	17.5
Average	9.972	39.888	5.191	20.764	17.73

The results have been normalized to 1W (forward power) into the dipole.

1g/10g Averaged	Average Measured SAR @ 1W Input	IEEE Target SAR @ 1W Input	Deviation (%)
1 gram	39.888	39.7	+ 0.474
10 gram	20.764	20.5	+ 1.29



### 1900 MHz System Validation - June 17, 2005

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: 151  
Ambient Temp: 23.4 °C; Fluid Temp: 22.7 °C; Barometric Pressure: 100.6 kPa; Humidity: 35%  
Communication System: CW  
Frequency: 1900 MHz; Duty Cycle: 1:1  
Medium: HSL1900 ( $\sigma = 1.40$  mho/m;  $\epsilon_r = 38.4$ ;  $\rho = 1000$  kg/m<sup>3</sup>)

- Probe: ET3DV6 - SN1590; ConvF(5.44, 5.44, 5.44); Calibrated: 20/05/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglass; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

**1900 MHz System Validation/Area Scan (5x8x1):** Measurement grid: dx=15mm, dy=15mm

**1900 MHz System Validation/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 94.6 V/m; Power Drift = -0.018 dB  
Peak SAR (extrapolated) = 17.7 W/kg  
**SAR(1 g) = 9.97 mW/g; SAR(10 g) = 5.20 mW/g**

**1900 MHz System Validation/Zoom Scan 2 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 93.6 V/m; Power Drift = -0.025 dB  
Peak SAR (extrapolated) = 17.9 W/kg  
**SAR(1 g) = 10.0 mW/g; SAR(10 g) = 5.19 mW/g**

**1900 MHz System Validation/Zoom Scan 3 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 94.1 V/m; Power Drift = -0.011 dB  
Peak SAR (extrapolated) = 18.1 W/kg  
**SAR(1 g) = 10.1 mW/g; SAR(10 g) = 5.21 mW/g**

**1900 MHz System Validation/Zoom Scan 4 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 94.8 V/m; Power Drift = 0.00 dB  
Peak SAR (extrapolated) = 17.8 W/kg  
**SAR(1 g) = 9.98 mW/g; SAR(10 g) = 5.20 mW/g**

**1900 MHz System Validation/Zoom Scan 5 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 94.8 V/m; Power Drift = -0.01 dB  
Peak SAR (extrapolated) = 17.7 W/kg  
**SAR(1 g) = 9.96 mW/g; SAR(10 g) = 5.19 mW/g**

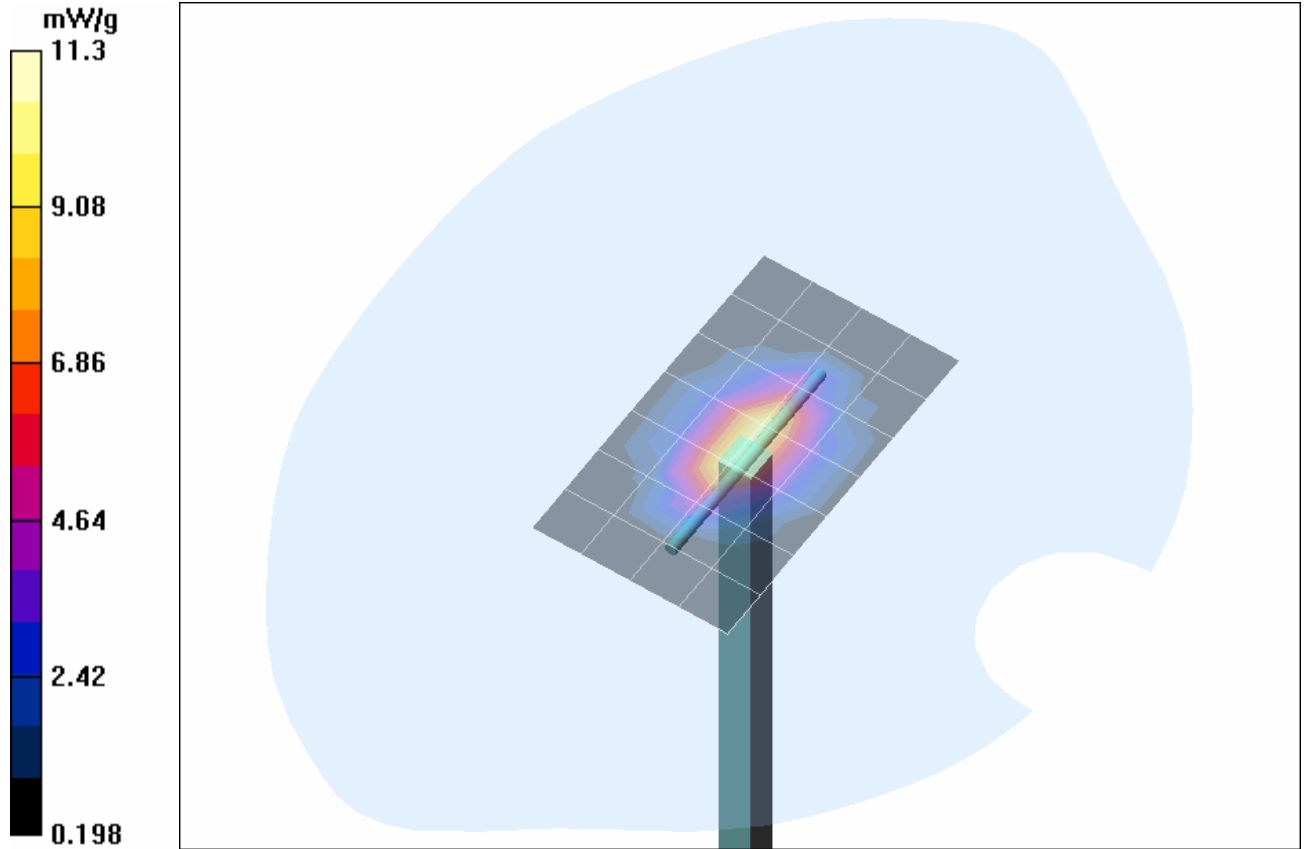
**1900 MHz System Validation/Zoom Scan 6 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 95.6 V/m; Power Drift = -0.081 dB  
Peak SAR (extrapolated) = 17.9 W/kg  
**SAR(1 g) = 9.99 mW/g; SAR(10 g) = 5.18 mW/g**

**1900 MHz System Validation/Zoom Scan 7 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 94.6 V/m; Power Drift = -0.019 dB  
Peak SAR (extrapolated) = 17.5 W/kg  
**SAR(1 g) = 9.89 mW/g; SAR(10 g) = 5.16 mW/g**

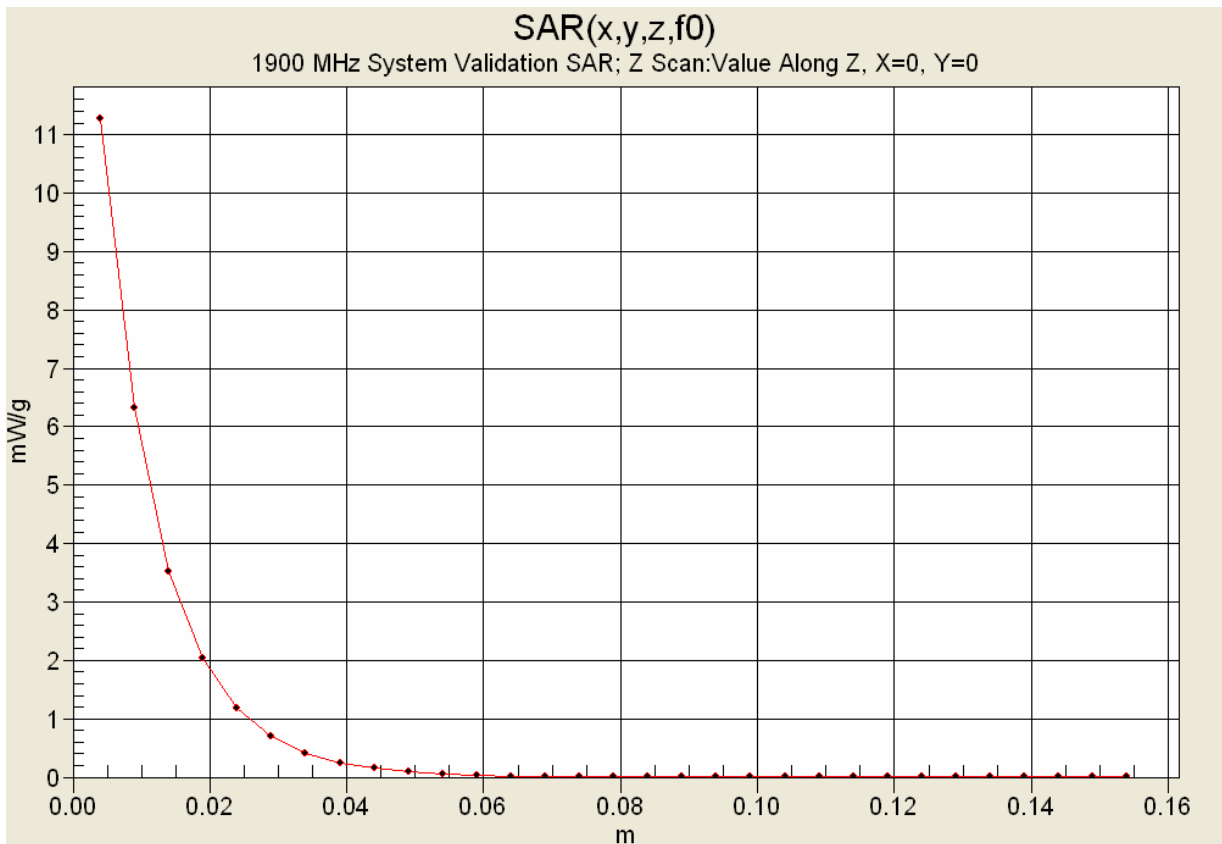
**1900 MHz System Validation/Zoom Scan 8 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 95.0 V/m; Power Drift = -0.016 dB  
Peak SAR (extrapolated) = 17.6 W/kg  
**SAR(1 g) = 9.95 mW/g; SAR(10 g) = 5.19 mW/g**

**1900 MHz System Validation/Zoom Scan 9 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 95.0 V/m; Power Drift = 0.00 dB  
Peak SAR (extrapolated) = 17.6 W/kg  
**SAR(1 g) = 9.96 mW/g; SAR(10 g) = 5.20 mW/g**

**1900 MHz System Validation/Zoom Scan 10 (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm  
Reference Value = 94.7 V/m; Power Drift = -0.00 dB  
Peak SAR (extrapolated) = 17.5 W/kg  
**SAR(1 g) = 9.92 mW/g; SAR(10 g) = 5.19 mW/g**



1 g average of 10 measurements: 9.972 mW/g  
10 g average of 10 measurements: 5.191 mW/g



### System Validation - 1900 MHz Dipole (Brain)

\*\*\*\*\*

Celltech Labs Inc.

Test Result for UIM Dielectric Parameter

Fri 17/Jun/2005

Freq Frequency(GHz)

FCC\_eH FCC OET 65 Supplement C (June 2001) Limits for Head Epsilon

FCC\_sH FCC OET 65 Supplement C (June 2001) Limits for Head Sigma

Test\_e Epsilon of UIM


Test\_s Sigma of UIM

\*\*\*\*\*

Freq	FCC_eH	FCC_sH	Test_e	Test_s
1.8000	40.00	1.40	38.82	1.30
1.8100	40.00	1.40	38.66	1.32
1.8200	40.00	1.40	38.64	1.33
1.8300	40.00	1.40	38.60	1.33
1.8400	40.00	1.40	38.57	1.34
1.8500	40.00	1.40	38.47	1.34
1.8600	40.00	1.40	38.40	1.36
1.8700	40.00	1.40	38.44	1.37
1.8800	40.00	1.40	38.34	1.38
1.8900	40.00	1.40	38.39	1.38
1.9000	40.00	1.40	38.37	1.40
1.9100	40.00	1.40	38.32	1.41
1.9200	40.00	1.40	38.34	1.42
1.9300	40.00	1.40	38.30	1.42
1.9400	40.00	1.40	38.31	1.44
1.9500	40.00	1.40	38.27	1.44
1.9600	40.00	1.40	38.20	1.46
1.9700	40.00	1.40	38.23	1.47
1.9800	40.00	1.40	38.11	1.49
1.9900	40.00	1.40	38.02	1.50
2.0000	40.00	1.40	38.11	1.52

Test Report Serial No.:	072605AL8-F659-S15H	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 10, 2005	Test Report Issue No.:	Issue 1 Rev 1
Description of Test:	RF Exposure	SAR	FCC 2.1093 IC RSS-102

## APPENDIX G - SAM PHANTOM CERTIFICATE OF CONFORMITY

<b>Applicant:</b>	Plantronics Inc.	<b>DUT Type:</b>	Wireless Office Headset System - UPCS Headset	
<b>Model(s):</b>	CS55 Headset, CS55 Micro Headset	<b>Tx Frequency Range:</b>	1921.536 - 1928.448 MHz	
2005 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the written permission of Celltech Labs Inc. 49 of 49				

# Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland, Phone +41 1 245 97 00, Fax +41 1 245 97 79

## Certificate of conformity / First Article Inspection

Item	SAM Twin Phantom V4.0
Type No	QD 000 P40 BA
Series No	TP-1002 and higher
Manufacturer / Origin	Untersee Composites Hauptstr. 69 CH-8559 Fruthwilen Switzerland

### Tests

The series production process used allows the limitation to test of first articles. Complete tests were made on the pre-series Type No. QD 000 P40 AA, Serial No. TP-1001 and on the series first article Type No. QD 000 P40 BA, Serial No. TP-1006. Certain parameters have been retested using further series units (called samples).

Test	Requirement	Details	Units tested
Shape	Compliance with the geometry according to the CAD model.	IT'IS CAD File (*)	First article, Samples
Material thickness	Compliant with the requirements according to the standards	2mm +/- 0.2mm in specific areas	First article, Samples
Material parameters	Dielectric parameters for required frequencies	200 MHz – 3 GHz Relative permittivity < 5 Loss tangent < 0.05.	Material sample TP 104-5
Material resistivity	The material has been tested to be compatible with the liquids defined in the standards	Liquid type HSL 1800 and others according to the standard.	Pre-series, First article

### Standards

- [1] CENELEC EN 50361
- [2] IEEE P1528-200x draft 6.5
- [3] IEC PT 62209 draft 0.9

(\*) The IT'IS CAD file is derived from [2] and is also within the tolerance requirements of the shapes of [1] and [3].

### Conformity

Based on the sample tests above, we certify that this item is in compliance with the uncertainty requirements of SAR measurements specified in standard [1] and draft standards [2] and [3].

Date 18.11.2001

Signature / Stamp



**Schmid & Partner  
Engineering AG**



Zeughausstrasse 43, CH-8004 Zurich  
Tel. +41 1 245 97 00, Fax +41 1 245 97 79